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FCC Sub6 REPORT

Certification

Applicant Name:
SAMSUNG Electronics Co., Ltd.

Address:
129, Samsung-ro, Yeongtong-gu,
Suwon-si, Gyeonggi-do, 16677, Rep. of Korea

Date of Issue:
May 09, 2023

Location:
HCT CO., LTD.,
74, Seoicheon-ro 578beon-gil, Majang-myeon,
Icheon-si, Gyeonggi-do, 17383, Rep. of KOREA

Report No.: HCT-RF-2305-FC023

FCC ID: A3LSMX818U

APPLICANT: SAMSUNG Electronics Co., Ltd.

Model(s): SM-X818U
EUT Type: Tablet
FCC Classification: PCS Licensed Transmitter (PCB)
FCC Rule Part(s): §22, §2

Mode (MHz)	Tx Frequency (MHz)	Emission Designator	Modulation	ERP	
				Max. Power (W)	Max. Power (dBm)
Sub6 n5/26 (5)	826.5 – 846.5	4M51G7D	PI/2 BPSK	0.149	21.74
		4M49G7D	QPSK	0.145	21.62
		4M52W7D	16QAM	0.118	20.71
		4M51W7D	64QAM	0.084	19.24
		4M51W7D	256QAM	0.046	16.64
Sub6 n5/26 (10)	829.0 – 844.0	8M98G7D	PI/2 BPSK	0.142	21.51
		9M01G7D	QPSK	0.139	21.44
		8M94W7D	16QAM	0.111	20.46
		9M98W7D	64QAM	0.082	19.12
		8M98W7D	256QAM	0.044	16.46
Sub6 n26 (15)	831.5 – 841.5	13M5G7D	PI/2 BPSK	0.142	21.52
		13M5G7D	QPSK	0.138	21.41
		13M5W7D	16QAM	0.112	20.50
		13M4W7D	64QAM	0.081	19.09
		13M5W7D	256QAM	0.045	16.50
Sub6 n26 (20)	834.0 – 839.0	17M9G7D	PI/2 BPSK	0.137	21.38
		17M9G7D	QPSK	0.135	21.29
		17M9W7D	16QAM	0.109	20.38
		17M9W7D	64QAM	0.079	18.95
		17M9W7D	256QAM	0.043	16.37

The measurements shown in this report were made in accordance with the procedures specified in CFR47 section §2.947. I assume full responsibility for the accuracy and completeness of these measurements, and for the qualifications of all persons taking them.
HCT CO., LTD. Certifies that no party to this application has subject to a denial of Federal benefits that includes FCC benefits pursuant to section 5301 of the Anti-Drug Abuse Act of 1998,21 U.S. C.853(a)

REVIEWED BY

Report prepared by : Jae Ryang Do **Engineer of Telecommunication Testing Center**	**Report approved by : Jong Seok Lee** **Manager of Telecommunication Testing Center**

This test results were applied only to the test methods required by the standard.

This laboratory is not accredited for the test results marked *.
The above Test Report is the accredited test result by (KS Q) ISO/IEC 17025 and KOLAS(Korea Laboratory Accreditation Scheme), which signed the ILAC-MRA. (HCT Accreditation No.: KT197)

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Version

TEST REPORT NO.	DATE	DESCRIPTION
HCT-RF-2305-FC023	May 09, 2023	- First Approval Report

The result shown in this test report refer only to the sample(s) tested unless otherwise stated.

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MEASUREMENT REPORT

1. GENERAL INFORMATION

Applicant Name:	SAMSUNG Electronics Co., Ltd.
Address:	129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea
FCC ID:	A3LSMX818U
Application Type:	Certification
FCC Classification:	PCS Licensed Transmitter (PCB)
FCC Rule Part(s):	§22, §2
EUT Type:	Tablet
Model(s):	SM-X818U
SCS(kHz):	15
Bandwidth(MHz):	5, 10, 15, 20
Waveform:	CP-OFDM, DFT-S-OFDM
Modulation:	DFT-S-OFDM: PI/2 BPSK, QPSK, 16QAM, 64QAM, 256QAM CP-OFDM: QPSK, 16QAM, 64QAM, 256QAM
Tx Frequency:	826.5 MHz – 846.5 MHz (Sub6 n 5 / 26 (5 MHz)) 829.0 MHz – 844.0 MHz (Sub6 n 5 / 26 (10 MHz)) 831.5 MHz – 841.5 MHz (Sub6 n 26 (15 MHz)) 834.0 MHz – 839.0 MHz (Sub6 n 26 (20 MHz))
Date(s) of Tests:	March 15, 2023 ~ May 07, 2023
Serial number:	Radiated: R32W2003H2Z Conducted: R32W2003GWK

2. INTRODUCTION

2.1. DESCRIPTION OF EUT

The EUT was a Tablet with UMTS and LTE, Sub6.

It also supports IEEE 802.11 a/b/g/n/ac/ax (20/40/80/160 MHz),WIFI 6E AIT, Keyboard, S-pen, mmWave.

2.2. MEASURING INSTRUMENT CALIBRATION

The measuring equipment, which was utilized in performing the tests documented herein, has been calibrated in accordance with the manufacturer's recommendations for utilizing calibration equipment, which is traceable to recognized national standards.

2.3. TEST FACILITY

The Fully-anechoic chamber and conducted measurement facility used to collect the radiated data are located at the **74, Seoicheon-ro 578beon-gil, Majang-myeon, Icheon-si, Gyeonggi-do, 17383, Rep. of KOREA**.

3. DESCRIPTION OF TESTS

3.1 TEST PROCEDURE

Test Description	Test Procedure Used
Occupied Bandwidth	- KDB 971168 D01 v03r01 – Section 4.3 - ANSI C63.26-2015 – Section 5.4.4
Band Edge	- KDB 971168 D01 v03r01 – Section 6.0 - ANSI C63.26-2015 – Section 5.7
Spurious and Harmonic Emissions at Antenna Terminal	- KDB 971168 D01 v03r01 – Section 6.0 - ANSI C63.26-2015 – Section 5.7
Peak- to- Average Ratio	- KDB 971168 D01 v03r01 – Section 5.7 - ANSI C63.26-2015 – Section 5.2.3.4
Conducted Output Power	- N/A (See SAR Report)
Frequency stability	- ANSI C63.26-2015 – Section 5.6
Effective Radiated Power/ Effective Isotropic Radiated Power	- KDB 971168 D01 v03r01 – Section 5.2 & 5.8 - ANSI/TIA-603-E-2016 – Section 2.2.17
Radiated Spurious and Harmonic Emissions	- KDB 971168 D01 v03r01 – Section 6.2 - ANSI/TIA-603-E-2016 – Section 2.2.12

3.2 RADIATED POWER

Test Overview

Radiated tests are performed in the Fully-anechoic chamber.

The equipment under test is placed on a non-conductive table 3-meters away from the receive antenna in accordance with ANSI/TIA-603-E-2016 Clause 2.2.17.

Test Settings

1. Radiated power measurements are performed using the signal analyzer's "channel power" measurement capability for signals with continuous operation.
2. RBW = 1 – 5 % of the expected OBW, not to exceed 1 MHz
3. VBW ≥ 3 x RBW
4. Span = 1.5 times the OBW
5. No. of sweep points > 2 x span / RBW
6. Detector = RMS
7. Trigger is set to "free run" for signals with continuous operation with the sweep times set to "auto".
8. The integration bandwidth was roughly set equal to the measured OBW of the signal for signals with continuous operation.
9. Trace mode = trace averaging (RMS) over 100 sweeps
10. The trace was allowed to stabilize

Test Note

1. The turntable is rotated through 360 degrees, and the receiving antenna scans in order to determine the level of the maximized emission.
2. A half wave dipole is then substituted in place of the EUT. For emissions above 1 GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator and the previously recorded signal was duplicated.

   The power is calculated by the following formula;

   $$P_{d\,(dBm)} = Pg_{\,(dBm)} - \text{cable loss}_{\,(dB)} + \text{antenna gain}_{\,(dB)}$$

   Where: P_d is the dipole equivalent power and P_g is the generator output power into the substitution antenna.
3. The maximum value is calculated by adding the forward power to the calibrated source plus its appropriate gain value. These steps are repeated with the receiving antenna in both vertical and horizontal polarization. the difference

   between the gain of the horn and an isotropic antenna are taken into consideration
4. The EUT was tested in three orthogonal planes(X, Y, Z) and in all possible test configurations and positioning.
5. All measurements are performed as RMS average measurements while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies.

3.3 RADIATED SPURIOUS EMISSIONS

Test Overview

Radiated tests are performed in the Fully-anechoic chamber.

Radiated Spurious Emission Measurements at 3 meters by Substitution Method according to ANSI/TIA-603-E-2016.

Test Settings

1. RBW = 100 kHz for emissions below 1 GHz and 1MHz for emissions above 1 GHz
2. VBW ≥ 3 x RBW
3. Span = 1.5 times the OBW
4. No. of sweep points > 2 x span / RBW
5. Detector = Peak
6. Trace mode = Max Hold
7. The trace was allowed to stabilize
8. Test channel : Low/ Middle/ High
9. Frequency range : We are performed all frequency to 10^{th} harmonics from 9 kHz.

Test Note

1. Measurements value show only up to 3 maximum emissions noted, or would be lesser if no specific emissions from the EUT are recorded (ie: margin > 20 dB from the applicable limit) and considered that's already beyond the background noise floor.
2. The EUT was tested in three orthogonal planes(X, Y, Z) and in all possible test configurations and positioning. The worst case emissions are reported with the EUT positioning, modulations, RB sizes and offsets, and channel bandwidth configurations shown in the test data
3. For spurious emissions above 1GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator and the previously recorded signal was duplicated.
   The spurious emissions is calculated by the following formula;

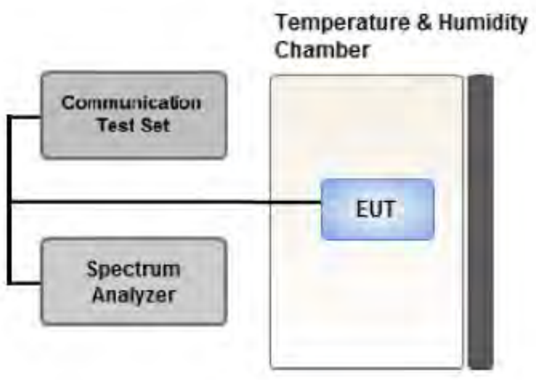
$$Result_{(dBm)} = Pg_{(dBm)} - cable\ loss_{(dB)} + antenna\ gain_{(dBi)}$$

   Where: P_g is the generator output power into the substitution antenna.

   If the fundamental frequency is below 1 GHz, RF output power has been converted to EIRP.

$$EIRP_{(dBm)} = ERP_{(dBm)} + 2.15$$

3.4 PEAK- TO- AVERAGE RATIO



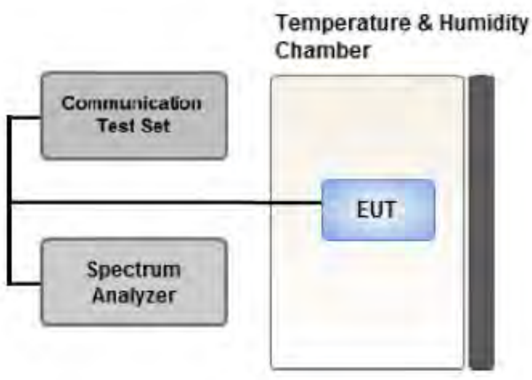
Test setup

① **CCDF Procedure for PAPR**

Test Settings

1. Set resolution/measurement bandwidth ≥ signal's occupied bandwidth;
2. Set the number of counts to a value that stabilizes the measured CCDF curve;
3. Set the measurement interval as follows:
   .- for continuous transmissions, set to 1 ms,
   .- or burst transmissions, employ an external trigger that is synchronized with the EUT burst timing sequence, or use the internal burst trigger with a trigger level that allows the burst to stabilize and set the measurement interval to a time that is less than or equal to the burst duration.
4. Record the maximum PAPR level associated with a probability of 0.1 %.

3.5 OCCUPIED BANDWIDTH.



Test setup

The width of a frequency band such that, below the lower and above the upper frequency limits, the mean powers emitted are each equal to a specified percentage 0.5 % of the total mean power of a given emission.

The EUT makes a call to the communication simulator.

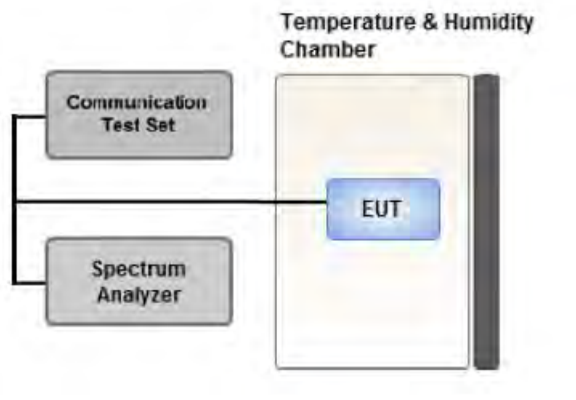
The conducted occupied bandwidth used the power splitter via EUT RF power connector between simulation base station and spectrum analyzer.

The communication simulator station system controlled a EUT to export maximum output power under transmission mode and specific channel frequency. Use OBW measurement function of Spectrum analyzer to measure 99 % occupied bandwidth

Test Settings

1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99 % occupied bandwidth and the 26 dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
2. RBW = 1 – 5 % of the expected OBW
3. VBW ≥ 3 x RBW
4. Detector = Peak
5. Trace mode = max hold
6. Sweep = auto couple
7. The trace was allowed to stabilize
8. If necessary, steps 2 – 7 were repeated after changing the RBW such that it would be within 1 – 5 % of the 99 % occupied bandwidth observed in Step 7

3.6 SPURIOUS AND HARMONIC EMISSIONS AT ANTENNA TERMINAL



Test setup

Test Overview

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic.

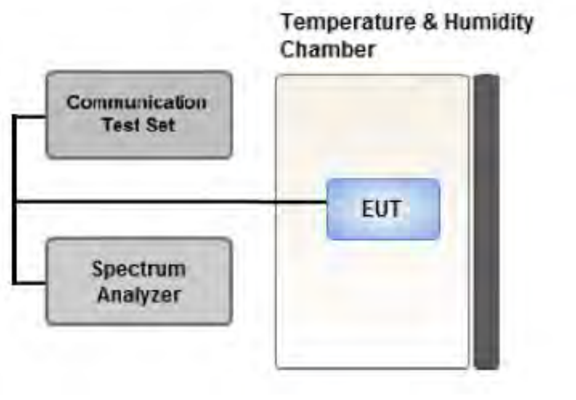
All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies.

All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

Test Settings

1. RBW = 1 MHz
2. VBW ≥ 3 MHz
3. Detector = RMS
4. Trace Mode = trace average
5. Sweep time = auto
6. Number of points in sweep ≥ 2 x Span / RBW

3.7 BAND EDGE



Test setup

Test Overview

All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

Test Settings

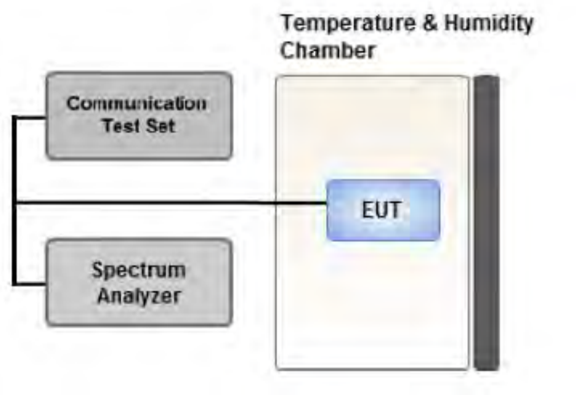
1. Start and stop frequency were set such that the band edge would be placed in the center of the plot
2. Span was set large enough so as to capture all out of band emissions near the band edge
3. RBW > 1 % of the emission bandwidth
4. VBW > 3 x RBW
5. Detector = RMS
6. Number of sweep points ≥ 2 x Span/RBW
7. Trace mode = trace average
8. Sweep time = auto couple
9. The trace was allowed to stabilize

Test Notes

According to FCC 22.917, 24.238, 27.53 specified that power of any emission outside of The authorized operating frequency ranges must be attenuated below the transmitting power (P) by a factor of at least 43 + 10 log(P) dB.
In the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed.
All measurements were done at 2 channels(low and high operational frequency range.)
The band edge measurement used the power splitter via EUT RF power connector between simulation base station and spectrum analyzer.

Where Margin < 1 dB the emission level is either corrected by 10 log(1 MHz/ RB) or the emission is integrated over a 1 MHz bandwidth to determine the final result. When using the integration method the integration window is either centered on the emission or, for emissions at the band edge, centered by an offset of 500 kHz from the block edge so that the integration window is the 1 MHz adjacent to the block edge.

3.8 FREQUENCY STABILITY / VARIATION OF AMBIENT TEMPERATURE



Test setup

Test Overview

Frequency stability testing is performed in accordance with the guidelines of ANSI C63.26-2015.

The frequency stability of the transmitter is measured by:

1. Temperature:

   The temperature is varied from -30 °C to +50 °C in 10 °C increments using an environmental chamber.

2. Primary Supply Voltage:

   .- Unless otherwise specified, vary primary supply voltage from 85 % to 115 % of the nominal value for other than hand carried battery equipment.

   .- For hand carried, battery powered equipment, reduce the primary ac or dc supply voltage to the battery operating end point, which shall be specified by the manufacturer.

Test Settings

1. The carrier frequency of the transmitter is measured at room temperature (20 °C to provide a reference).
2. The equipment is turned on in a "standby" condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
3. Frequency measurements are made at 10 °C intervals ranging from -30 °C to +50 °C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

3.9 WORST CASE(RADIATED TEST)

- The EUT was tested in three orthogonal planes(X, Y, Z) and in all possible test configurations and positioning.
- All modes of operation were investigated and the worst case configuration results are reported.
  Mode: NSA, SA(n26 SA only, n5 SA & NSA)
  Worst case : SA
  Mode : Stand alone, Stand alone + External accessories (Earphone, AC adapter, etc)
  Worst case : Stand alone
- We were performed the RSE test in condition of co-location.
  Mode : Stand alone, Simultaneous transmission scenarios
  Worst case : Stand alone
- In the case of radiated spurious emissions, all bandwidth of operation were investigated and the worst case bandwidth results are reported. (Worst case : 5 MHz)
- Sub6 n26(5,10,15,20 M) overlaps the entire frequency range of Sub6 n5(5,10,15,20 M) and they have the same Tune-up power.
  Therefore, test data provided in this report covers Sub6 n5 as well as Sub6 n26.
- All RB sizes, offsets of operation were investigated and the worst case configuration results are reported.
  Please refer to the table below.

[Worst case]

Test Description	Modulation	RB size	RB offset	Axis
Effective Radiated Power	Pi2/BPSK QPSK, 16QAM, 64QAM, 256QAM	See Section 8.1		X
Radiated Spurious and Harmonic Emissions	Pi2/BPSK	See Section 8.2		Y

3.10 WORST CASE(CONDUCTED TEST)

- Waveform : All Waveform of operation were investigated and the worst case configuration results are reported.
  (Worst case: DFT-S-OFDM)
- Modulation : All Modulation of operation were investigated and the worst case configuration results are reported.
  (Worst case: PI/2 BPSK)
- All modes of operation were investigated and the worst case configuration results are reported.
  Mode: NSA, SA(n26 SA only, n5 SA & NSA)
  Worst case : SA
- Sub6 n26(5,10,15,20 M) overlaps the entire frequency range of Sub6 n5(5,10,15,20 M) and they have the same Tune-up power.
- All RB sizes, offsets of operation were investigated and the worst case configuration results are reported.
  Please refer to the table below.

[Worst case]

Test Description	Modulation	Bandwidth (MHz)	Frequency	RB size	RB offset
Occupied Bandwidth	Pi2/BPSK QPSK, 16QAM, 64QAM, 256QAM	5, 10, 15, 20	Mid	Full RB	0
Peak-To-Average Ratio	Pi2/BPSK QPSK, 16QAM, 64QAM, 256QAM	5, 10, 15, 20	Mid	Full RB	0
Band-edge	Pi2/BPSK	5	Low	1	0
			High	1	24
		10	Low	1	0
			High	1	49
		15	Low	1	0
			High	1	74
		20	Low	1	0
			High	1	99
		5, 10, 15, 20	Low, High	Full RB	0
Spurious and Harmonic Emissions at Antenna Terminal	Pi2/BPSK	5, 10, 15, 20	Low, Mid, High	1	0

4. LIST OF TEST EQUIPMENT

Equipment	Model	Manufacture	Serial No.	Due to Calibration	Calibration Interval
Precision Dipole Antenna	UHAP	Schwarzbeck	01273	03/27/2024	Biennial
Precision Dipole Antenna	UHAP	Schwarzbeck	01274	03/27/2024	Biennial
Horn Antenna(1~18 GHz)	BBHA 9120D	Schwarzbeck	02289	03/21/2024	Biennial
Horn Antenna(1~18 GHz)	BBHA 9120D	Schwarzbeck	9120D-1299	04/27/2025	Biennial
Horn Antenna(15~40 GHz)	BBHA 9170	Schwarzbeck	BBHA9170342	09/29/2024	Biennial
Horn Antenna(15~40 GHz)	BBHA 9170	Schwarzbeck	BBHA9170124	03/28/2025	Biennial
Loop Antenna(9 kHz~30 MHz)	FMZB1513	Rohde & Schwarz	1513-175	06/04/2023	Biennial
Bilog Antenna	VULB9160	Schwarzbeck	3150	03/09/2025	Biennial
Hybrid Antenna	VULB9160	Schwarzbeck	760	02/24/2025	Biennial
High Pass Filter	WHKX10-900-1000-15000-40SS	Wainwright Instruments	15	05/18/2023	Annual
High Pass Filter	WHKX10-2700-3000-18000-40SS	Wainwright Instruments	145	05/18/2023	Annual
High Pass Filter	WHNX6-4740-6000-26500-40CC	Wainwright Instruments	11	05/18/2023	Annual
LOW NOISE AMP (100 MHz ~ 18 GHz)	CBLU1183540B-01	CERNEX	26822	05/18/2023	Annual
Power Amplifier	CBL18265035	CERNEX	22966	12/01/2023	Annual
Power Amplifier	CBL26405040	CERNEX	25956	03/02/2024	Annual
DC Power Supply	E3632A	Hewlett Packard	MY40004427	09/05/2023	Annual
Power Splitter(DC~26.5 GHz)	11667B	Hewlett Packard	11275	03/02/2024	Annual
Chamber	SU-642	ESPEC	93008124	02/22/2024	Annual
Signal Analyzer(10 Hz~26.5 GHz)	N9020A	Agilent	MY51110063	04/11/2024	Annual
ATTENUATOR(20 dB)	8493C	Hewlett Packard	17280	04/19/2024	Annual
Spectrum Analyzer(10 Hz~40 GHz)	FSV40	REOHDE & SCHWARZ	101436	02/22/2024	Annual
Base Station	8960 (E5515C)	Agilent	MY48360800	08/18/2023	Annual
Wideband Radio Communication Tester	MT8821C	Anritsu Corp.	6262287700	05/19/2023	Annual
Wideband Radio Communication Tester	MT8000A	Anritsu Corp.	6262302511	05/18/2023	Annual
SIGNAL GENERATOR (100 kHz~40 GHz)	SMB100A	REOHDE & SCHWARZ	177633	07/05/2023	Annual
Signal Analyzer(5 Hz~40.0 GHz)	N9030B	KEYSIGHT	MY55480167	05/30/2023	Annual
4-Way Divider	ZC4PD-K1844+	Mini-Circuits	942907	09/27/2023	Annual
FCC LTE Mobile Conducted RF Automation Test Software	-	HCT CO., LTD.,	-	-	-

Note:

1. Equipment listed above that has a calibration due date during the testing period, the testing is completed before equipment expiration date.
2. Espectially, all antenna for measurement is calibrated in accordance with the requirements of C63.5 (Version : 2017).

5. MEASUREMENT UNCERTAINTY

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.4:2014. All measurement uncertainty values are shown with a coverage factor of *k* = 2 to indicate a 95 % level of confidence. The measurement data shown herein meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and, thus, can be compared directly to specified limits to determine compliance.

Parameter	Expanded Uncertainty (±dB)
Conducted Disturbance (150 kHz ~ 30 MHz)	1.90 (Confidence level about 95 %, *k*=2)
Radiated Disturbance (9 kHz ~ 30 MHz)	4.14 (Confidence level about 95 %, *k*=2)
Radiated Disturbance (30 MHz ~ 1 GHz)	5.82 (Confidence level about 95 %, *k*=2)
Radiated Disturbance (1 GHz ~ 18 GHz)	5.74 (Confidence level about 95 %, *k*=2)
Radiated Disturbance (18 GHz ~ 40 GHz)	5.76 (Confidence level about 95 %, *k*=2)
Radiated Disturbance (Above 40 GHz)	5.52 (Confidence level about 95 %, *k*=2)

6. SUMMARY OF TEST RESULTS

6.1 Test Condition : Conducted Test

Test Description	FCC Part Section(s)	Test Limit	Test Result
Occupied Bandwidth	§2.1049	N/A	PASS
Band Edge / Spurious and Harmonic Emissions at Antenna Terminal.	§2.1051, §22.917(a)	< 43 + 10log10 (P[Watts]) at Band Edge and for all out-of-band emissions	PASS
Conducted Output Power	§2.1046	N/A	See Note1
Peak- to- Average Ratio	§22.913(d)	< 13 dB	PASS
Frequency stability / variation of ambient temperature	§2.1055, §22.355	< 2.5 ppm	PASS

Note:

1. See SAR Report

6.2 Test Condition : Radiated Test

Test Description	FCC Part Section(s)	Test Limit	Test Result
Effective Radiated Power	§22.913(a)(5)	< 7 Watts max. ERP	PASS
Radiated Spurious and Harmonic Emissions	§2.1053, §22.917(a)	< 43 + 10log10 (P[Watts]) for all out-of band emissions	PASS

7. SAMPLE CALCULATION

7.1 ERP Sample Calculation

Ch./ Freq.		Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBd)	C.L	Pol.	ERP	
channel	Freq.(MHz)						W	dBm
128	824.20	-21.37	38.40	-10.61	0.95	H	0.483	26.84

ERP = Substitute LEVEL(dBm) + Ant. Gain – CL(Cable Loss)

1) The EUT mounted on a non-conductive turntable is 2.5 meter above test site ground level.
2) During the test , the turn table is rotated until the maximum signal is found.
3) Record the field strength meter's level.
4) Replace the EUT with dipole/Horn antenna that is connected to a calibrated signal generator.
5) Increase the signal generator output till the field strength meter's level is equal to the item (3).
6) The signal generator output level with Ant. Gain and cable loss are the rating of effective radiated power.

7.2 EIRP Sample Calculation

Ch./ Freq.		Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain (dBi)	C.L	Pol.	EIRP	
channel	Freq.(MHz)						W	dBm
20175	1,732.50	-15.75	18.45	9.90	1.76	H	0.456	26.59

EIRP = Substitute LEVEL(dBm) + Ant. Gain – CL(Cable Loss)

1) The EUT mounted on a non-conductive turntable is 2.5 meter above test site ground level.
2) During the test , the turn table is rotated until the maximum signal is found.
3) Record the field strength meter's level.
4) Replace the EUT with dipole/Horn antenna that is connected to a calibrated signal generator.
5) Increase the signal generator output till the field strength meter's level is equal to the item (3).
6) The signal generator output level with Ant. Gain and cable loss are the rating of equivalent isotropic radiated power.

7.3. Emission Designator

GSM Emission Designator

Emission Designator = 249KGXW

GSM BW = 249 kHz

G = Phase Modulation

X = Cases not otherwise covered

W = Combination (Audio/Data)

EDGE Emission Designator

Emission Designator = 249KG7W

GSM BW = 249 kHz

G = Phase Modulation

7 = Quantized/Digital Info

W = Combination (Audio/Data)

WCDMA Emission Designator

Emission Designator = 4M17F9W

WCDMA BW = 4.17 MHz

F = Frequency Modulation

9 = Composite Digital Info

W = Combination (Audio/Data)

QPSK Modulation

Emission Designator = 4M48G7D

LTE BW = 4.48 MHz

G = Phase Modulation

7 = Quantized/Digital Info

D = Data transmission; telemetry; telecommand

QAM Modulation

Emission Designator = 4M48W7D

LTE BW = 4.48 MHz

W = Amplitude/Angle Modulated

7 = Quantized/Digital Info

D = Data transmission; telemetry; telecommand

8. TEST DATA

8.1 EFFECTIVE RADIATED POWER

Freq (MHz)	Mod/ Bandwidth [SCS (kHz)]	Modulation	Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain(dBd)	C.L	Pol	Limit	ERP		RB	
								W	W	dBm	Size	Offset
826.5	Sub6 n5/26 5 MHz [15 kHz]	PI/2 BPSK	-28.63	32.27	-10.05	1.39	H	< 7.00	0.121	20.83	1	23
		QPSK	-28.69	32.21	-10.05	1.39	H		0.119	20.77		
		16-QAM	-29.69	31.21	-10.05	1.39	H		0.095	19.77		
		64-QAM	-30.99	29.91	-10.05	1.39	H		0.070	18.47		
		256-QAM	-33.60	27.30	-10.05	1.39	H		0.039	15.86		
836.5		PI/2 BPSK	-28.40	32.89	-10.05	1.40	H		0.139	21.44	1	1
		QPSK	-28.42	32.87	-10.05	1.40	H		0.139	21.42		
		16-QAM	-29.40	31.89	-10.05	1.40	H		0.111	20.44		
		64-QAM	-30.85	30.44	-10.05	1.40	H		0.079	18.99		
		256-QAM	-33.41	27.88	-10.05	1.40	H		0.044	16.43		
846.5		PI/2 BPSK	-28.48	33.20	-10.05	1.41	H		0.149	21.74	1	1
		QPSK	-28.60	33.08	-10.05	1.41	H		0.145	21.62		
		16-QAM	-29.51	32.17	-10.05	1.41	H		0.118	20.71		
		64-QAM	-30.98	30.70	-10.05	1.41	H		0.084	19.24		
		256-QAM	-33.58	28.10	-10.05	1.41	H		0.046	16.64		

Freq (MHz)	Mod/ Bandwidth [SCS (kHz)]	Modulation	Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain(dBd)	C.L	Pol	Limit	ERP		RB	
								W	W	dBm	Size	Offset
829.0	Sub6 n5/26 10 MHz [15 kHz]	PI/2 BPSK	-28.51	32.51	-10.05	1.39	H	< 7.00	0.128	21.07	1	50
		QPSK	-28.60	32.42	-10.05	1.39	H		0.125	20.98		
		16-QAM	-29.50	31.52	-10.05	1.39	H		0.102	20.08		
		64-QAM	-30.90	30.12	-10.05	1.39	H		0.074	18.68		
		256-QAM	-33.57	27.45	-10.05	1.39	H		0.040	16.01		
836.5		PI/2 BPSK	-28.58	32.71	-10.05	1.40	H		0.134	21.26	1	1
		QPSK	-28.60	32.69	-10.05	1.40	H		0.133	21.24		
		16-QAM	-29.48	31.81	-10.05	1.40	H		0.109	20.36		
		64-QAM	-30.99	30.30	-10.05	1.40	H		0.077	18.85		
		256-QAM	-33.60	27.69	-10.05	1.40	H		0.042	16.24		
844.0		PI/2 BPSK	-28.51	32.97	-10.05	1.41	H		0.142	21.51	1	1
		QPSK	-28.58	32.90	-10.05	1.41	H		0.139	21.44		
		16-QAM	-29.56	31.92	-10.05	1.41	H		0.111	20.46		
		64-QAM	-30.90	30.58	-10.05	1.41	H		0.082	19.12		
		256-QAM	-33.56	27.92	-10.05	1.41	H		0.044	16.46		

Freq (MHz)	Mod/ Bandwidth [SCS (kHz)]	Modulation	Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain(dBd)	C.L	Pol	Limit	ERP		RB	
								W	W	dBm	Size	Offset
831.5	Sub6 n5/26 15 MHz [15 kHz]	PI/2 BPSK	-28.51	32.62	-10.05	1.39	H	< 7.00	0.131	21.18	1	77
		QPSK	-28.58	32.55	-10.05	1.39	H		0.129	21.11		
		16-QAM	-29.50	31.63	-10.05	1.39	H		0.104	20.19		
		64-QAM	-30.99	30.14	-10.05	1.39	H		0.074	18.70		
		256-QAM	-33.53	27.60	-10.05	1.39	H		0.041	16.16		
836.5		PI/2 BPSK	-28.47	32.82	-10.05	1.40	H		0.137	21.37	1	39
		QPSK	-28.61	32.68	-10.05	1.40	H		0.133	21.23		
		16-QAM	-29.56	31.73	-10.05	1.40	H		0.107	20.28		
		64-QAM	-30.96	30.33	-10.05	1.40	H		0.077	18.88		
		256-QAM	-33.54	27.75	-10.05	1.40	H		0.043	16.30		
841.5		PI/2 BPSK	-28.44	32.98	-10.05	1.41	H		0.142	21.52	1	1
		QPSK	-28.55	32.87	-10.05	1.41	H		0.138	21.41		
		16-QAM	-29.46	31.96	-10.05	1.41	H		0.112	20.50		
		64-QAM	-30.87	30.55	-10.05	1.41	H		0.081	19.09		
		256-QAM	-33.46	27.96	-10.05	1.41	H		0.045	16.50		

Freq (MHz)	Mod/ Bandwidth [SCS (kHz)]	Modulation	Measured Level (dBm)	Substitute Level (dBm)	Ant. Gain(dBd)	C.L	Pol	Limit	ERP		RB	
								W	W	dBm	Size	Offset
834.0	Sub6 n5/26 20 MHz [15 kHz]	PI/2 BPSK	-28.45	32.76	-10.05	1.39	H	< 7.00	0.136	21.32	1	53
		QPSK	-28.63	32.58	-10.05	1.39	H		0.130	21.14		
		16-QAM	-29.50	31.71	-10.05	1.39	H		0.106	20.27		
		64-QAM	-31.02	30.19	-10.05	1.39	H		0.075	18.75		
		256-QAM	-33.60	27.61	-10.05	1.39	H		0.041	16.17		
836.5		PI/2 BPSK	-28.61	32.68	-10.05	1.40	H		0.133	21.23	1	53
		QPSK	-28.67	32.62	-10.05	1.40	H		0.131	21.17		
		16-QAM	-29.54	31.75	-10.05	1.40	H		0.107	20.30		
		64-QAM	-30.98	30.31	-10.05	1.40	H		0.077	18.86		
		256-QAM	-33.62	27.67	-10.05	1.40	H		0.042	16.22		
839.0		PI/2 BPSK	-28.62	32.83	-10.05	1.40	H		0.137	21.38	1	1
		QPSK	-28.71	32.74	-10.05	1.40	H		0.135	21.29		
		16-QAM	-29.62	31.83	-10.05	1.40	H		0.109	20.38		
		64-QAM	-31.05	30.40	-10.05	1.40	H		0.079	18.95		
		256-QAM	-33.63	27.82	-10.05	1.40	H		0.043	16.37		

8.2 RADIATED SPURIOUS EMISSIONS

- NR Band: N26(5)
- Bandwidth: 5 MHz
- Modulation: PI/2 BPSK
- Distance: 3 meters
- SCS: 15 kHz
- Limit: -13.00 dBm

Ch	Freq (MHz)	Measured Level (dBm)	Ant. Gain (dBi)	Substitute Level (dBm)	C.L	Pol	Result (dBm)	Limit (dBm)	RB	
									Size	Offset
165300 (826.5)	1 653.00	-56.70	9.20	-65.61	2.03	V	-58.44	-13.00	1	23
	2 479.50	-47.47	10.20	-50.72	2.45	V	-42.97	-13.00		
	3 306.00	-60.25	10.90	-62.29	2.92	V	-54.31	-13.00		
	4 132.50	-59.05	11.30	-58.90	3.25	H	-50.85	-13.00		
	4 959.00	-59.08	10.90	-54.79	3.58	H	-47.47	-13.00		
167300 (836.5)	1 673.00	-52.06	9.20	-61.24	2.03	V	-54.07	-13.00	1	1
	2 509.50	-46.69	10.30	-51.22	2.50	H	-43.42	-13.00		
	3 346.00	-59.66	10.95	-62.55	2.89	H	-54.49	-13.00		
	4 182.50	-61.53	11.30	-61.38	3.30	H	-53.38	-13.00		
	5 019.00	-60.78	10.70	-55.72	3.55	V	-48.57	-13.00		
169300 (846.5)	1 693.00	-51.63	9.40	-60.25	2.00	V	-52.85	-13.00	1	1
	2 539.50	-47.88	10.30	-52.71	2.52	H	-44.93	-13.00		
	3 386.00	-60.17	11.00	-62.65	2.94	V	-54.59	-13.00		
	4 232.50	-60.64	11.20	-59.72	3.28	V	-51.80	-13.00		
	5 079.00	-61.61	10.70	-56.45	3.61	V	-49.36	-13.00		

8.3 PEAK-TO-AVERAGE RATIO

Band	Band Width	Frequency (MHz)	Modulation	Resource Block Size	Resource Block Offset	Data (dB)
5/26	5 MHz	836.5	BPSK	25	0	4.34
			QPSK			4.94
			16QAM			6.18
			64QAM			6.61
			256QAM			6.50
	10 MHz		BPSK	50		4.32
			QPSK			5.05
			16QAM			6.08
			64QAM			6.49
			256QAM			7.01
26	15 MHz		BPSK	75		4.30
			QPSK			4.98
			16QAM			5.92
			64QAM			6.38
			256QAM			6.62
	20 MHz		BPSK	100		4.15
			QPSK			4.79
			16QAM			5.82
			64QAM			6.26
			256-QAM			6.71

Note:

1. Plots of the EUT's Occupied Bandwidth are shown Page 55 ~ 74.

8.4 OCCUPIED BANDWIDTH

Band	Band Width	Frequency (MHz)	Modulation	Resource Block Size	Resource Block Offset	Data (MHz)
5/26	5 MHz	836.5	BPSK	25	0	4.5123
			QPSK			4.4919
			16QAM			4.5202
			64QAM			4.5055
			256QAM			4.5045
	10 MHz		BPSK	50		8.9746
			QPSK			9.0083
			16QAM			8.9435
			64QAM			8.9766
			256QAM			8.9800
26	15 MHz		BPSK	75		13.481
			QPSK			13.474
			16QAM			13.448
			64QAM			13.431
			256QAM			13.544
	20 MHz		BPSK	100		17.916
			QPSK			17.921
			16QAM			17.934
			64QAM			17.889
			256QAM			17.932

Note:

1. Plots of the EUT's Occupied Bandwidth are shown Page 35 ~ 54.

8.5 CONDUCTED SPURIOUS EMISSIONS

Band	Band Width (MHz)	Frequency (MHz)	Frequency of Maximum Harmonic (GHz)	Factor (dB)	Measurement Maximum Data (dBm)	Result (dBm)	Limit (dBm)
5/26	5	826.5	9.6959	30.815	-74.961	-44.146	-13.00
		836.5	3.8161	30.200	-75.725	-45.525	
		846.5	4.0474	30.200	-74.839	-44.639	
	10	829.0	8.2727	30.815	-74.867	-44.052	
		836.5	4.9731	30.200	-75.194	-44.994	
		844.0	5.2553	30.815	-75.018	-44.203	
26	15	831.5	9.1132	30.815	-74.957	-44.142	
		836.5	9.7169	30.815	-73.758	-42.943	
		841.5	8.2403	30.815	-74.664	-43.849	
	20	834.0	8.2582	30.815	-74.997	-44.182	
		836.5	3.7852	30.200	-75.016	-44.816	
		839.0	9.9761	30.815	-75.204	-44.389	

Note:

1. Plots of the EUT's Conducted Spurious Emissions are shown Page 99 ~ 110.
2. Conducted Spurious Emissions was Tested QPSK Modulation, Resource Block Size 1 and Resource Block Offset 0
3. Result (dBm) = Measurement Maximum Data (dBm) + Factor (dB)
4. Factor (dB) = Cable Loss + Ext. Attenuator + Power Splitter

Frequency Range (GHz)	Factor [dB]
0.03 – 1	27.494
1 – 5	30.200
5 – 10	30.815
10 – 15	31.340
15 – 20	31.713
Above 20	32.355

8.6 BAND EDGE

- Plots of the EUT's Band Edge are shown Page 75 ~ 98.

8.7 FREQUENCY STABILITY / VARIATION OF AMBIENT TEMPERATURE

- ▣ BandWidth: 5 MHz
- ▣ Voltage(100 %): 3.880 VDC
- ▣ Batt. Endpoint: 3.400 VDC
- ▣ LIMIT: Emission must remain in band

Test. Frequncy (MHz)	Voltage (%)	Temp. (℃)	Frequency (Hz)	Frequency Error (Hz)	Deviation (%)	ppm
836.5	100 %	+20(Ref)	836 499 997	0.0	0.000 000	0.000
	100 %	-30	836 499 992	-4.1	0.000 000	-0.005
	100 %	-20	836 499 995	-2.0	0.000 000	-0.002
	100 %	-10	836 499 992	-4.6	-0.000 001	-0.005
	100 %	0	836 499 992	-4.6	-0.000 001	-0.005
	100 %	+10	836 499 994	-2.5	0.000 000	-0.003
	100 %	+30	836 499 994	-2.6	0.000 000	-0.003
	100 %	+40	836 499 994	-2.9	0.000 000	-0.004
	100 %	+50	836 499 991	-5.1	-0.000 001	-0.006
	Batt. Endpoint	+20	836 499 991	-5.5	-0.000 001	-0.007

▣ BandWidth: 10 MHz

▣ Voltage(100 %): 3.880 VDC

▣ Batt. Endpoint: 3.400 VDC

▣ LIMIT: Emission must remain in band

Test. Frequncy (MHz)	Voltage (%)	Temp. (℃)	Frequency (Hz)	Frequency Error (Hz)	Deviation (%)	ppm
836.5	100 %	+20(Ref)	836 500 003	0.0	0.000 000	0.000
	100 %	-30	836 500 007	3.4	0.000 000	0.004
	100 %	-20	836 500 006	3.1	0.000 000	0.004
	100 %	-10	836 500 006	3.2	0.000 000	0.004
	100 %	0	836 500 008	4.5	0.000 001	0.005
	100 %	+10	836 500 007	3.8	0.000 000	0.005
	100 %	+30	836 500 007	4.0	0.000 000	0.005
	100 %	+40	836 500 007	3.7	0.000 000	0.004
	100 %	+50	836 500 007	4.0	0.000 000	0.005
	Batt. Endpoint	+20	836 500 007	4.0	0.000 000	0.005

▣ BandWidth: 15 MHz

▣ Voltage(100 %): 3.880 VDC

▣ Batt. Endpoint: 3.400 VDC

▣ LIMIT: Emission must remain in band

Test. Frequncy (MHz)	Voltage (%)	Temp. (℃)	Frequency (Hz)	Frequency Error (Hz)	Deviation (%)	ppm
836.5	100 %	+20(Ref)	836 500 002	0.0	0.000 000	0.000
	100 %	-30	836 500 003	1.4	0.000 000	0.002
	100 %	-20	836 500 003	1.0	0.000 000	0.001
	100 %	-10	836 500 002	0.2	0.000 000	0.000
	100 %	0	836 500 006	4.0	0.000 000	0.005
	100 %	+10	836 500 004	2.7	0.000 000	0.003
	100 %	+30	836 500 004	2.1	0.000 000	0.003
	100 %	+40	836 500 003	1.5	0.000 000	0.002
	100 %	+50	836 500 004	2.8	0.000 000	0.003
	Batt. Endpoint	+20	836 500 004	2.5	0.000 000	0.003

▣ BandWidth: 20 MHz

▣ Voltage(100 %): 3.880 VDC

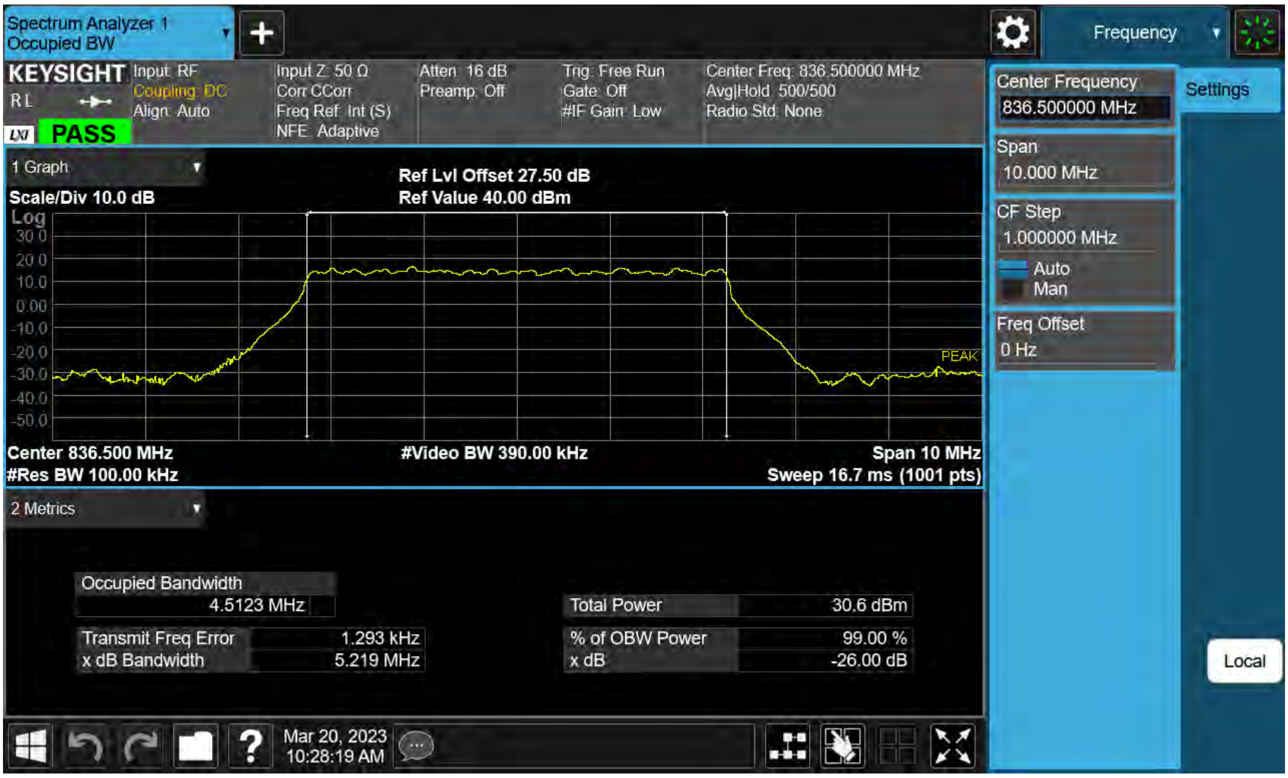
▣ Batt. Endpoint: 3.400 VDC

▣ LIMIT: Emission must remain in band

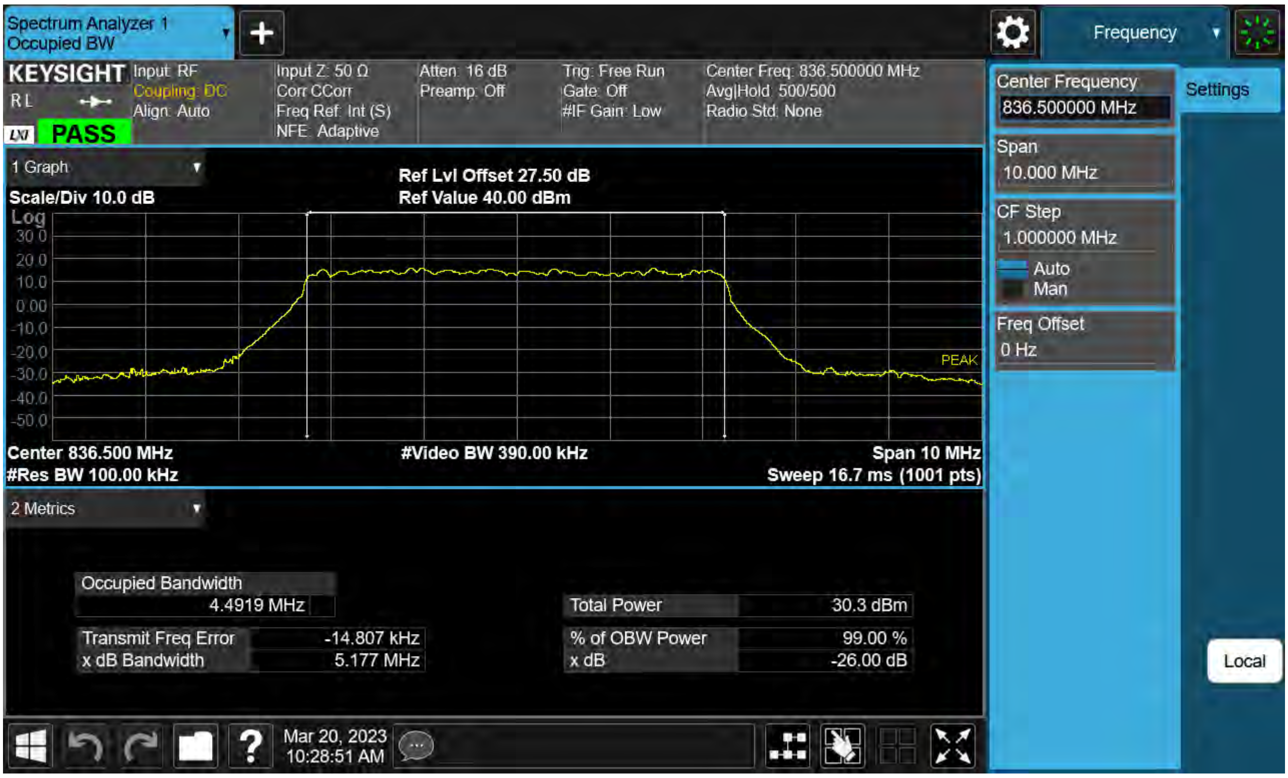
Test. Frequncy (MHz)	Voltage (%)	Temp. (℃)	Frequency (Hz)	Frequency Error (Hz)	Deviation (%)	ppm
836.5	100 %	+20(Ref)	836 500 000	0.0	0.000 000	0.000
	100 %	-30	836 499 999	-0.6	0.000 000	-0.001
	100 %	-20	836 499 998	-1.6	0.000 000	-0.002
	100 %	-10	836 499 998	-1.7	0.000 000	-0.002
	100 %	0	836 500 000	-0.1	0.000 000	0.000
	100 %	+10	836 499 999	-0.6	0.000 000	-0.001
	100 %	+30	836 500 001	0.9	0.000 000	0.001
	100 %	+40	836 499 998	-1.7	0.000 000	-0.002
	100 %	+50	836 500 002	2.2	0.000 000	0.003
	Batt. Endpoint	+20	836 499 999	-0.8	0.000 000	-0.001

9. TEST PLOTS

Sub6 n26. Occupied Bandwidth Plot (5 M BW Ch.167300 BPSK_RB 25_0)



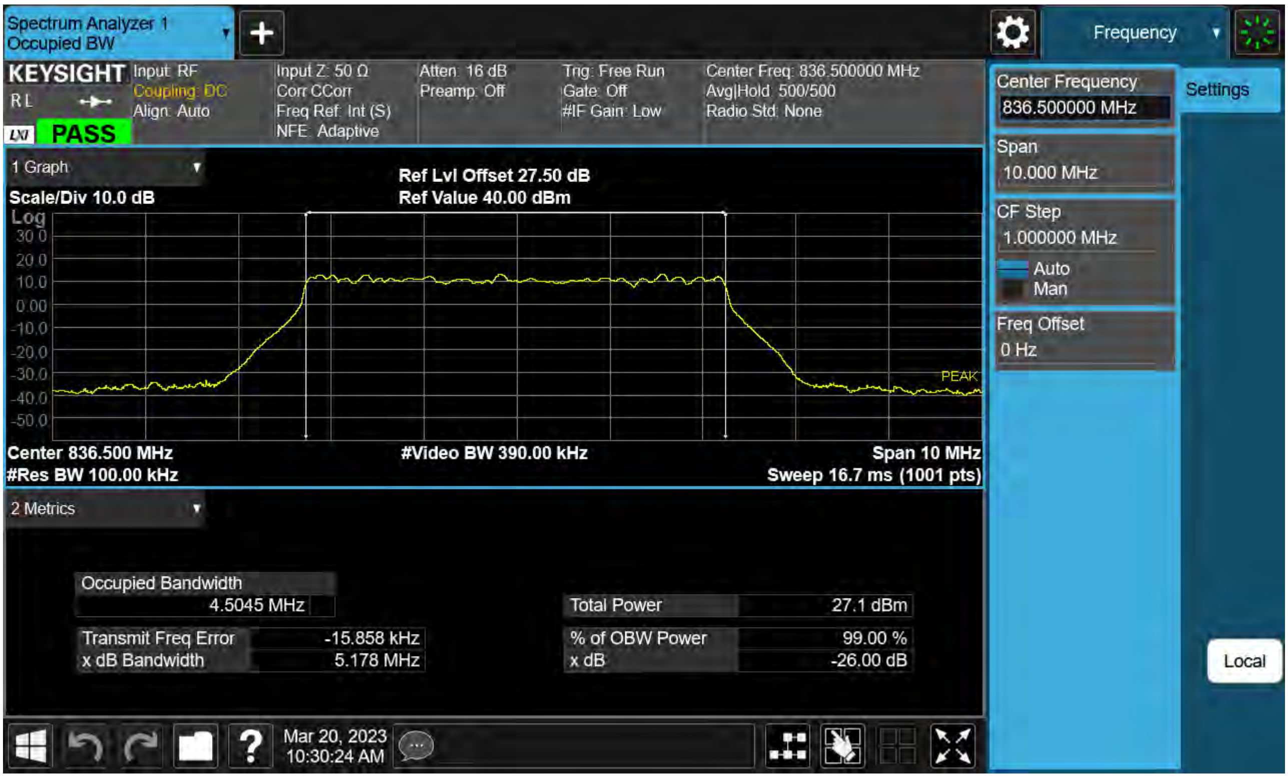
Sub6 n26. Occupied Bandwidth Plot (5 M BW Ch.167300 QPSK_RB 25_0)



Sub6 n26. Occupied Bandwidth Plot (5 M BW Ch.167300 16QAM_RB 25_0)

Sub6 n26. Occupied Bandwidth Plot (5 M BW Ch.167300 64QAM_RB 25_0)

Sub6 n26. Occupied Bandwidth Plot (5 M BW Ch.167300 256QAM_RB 25_0)

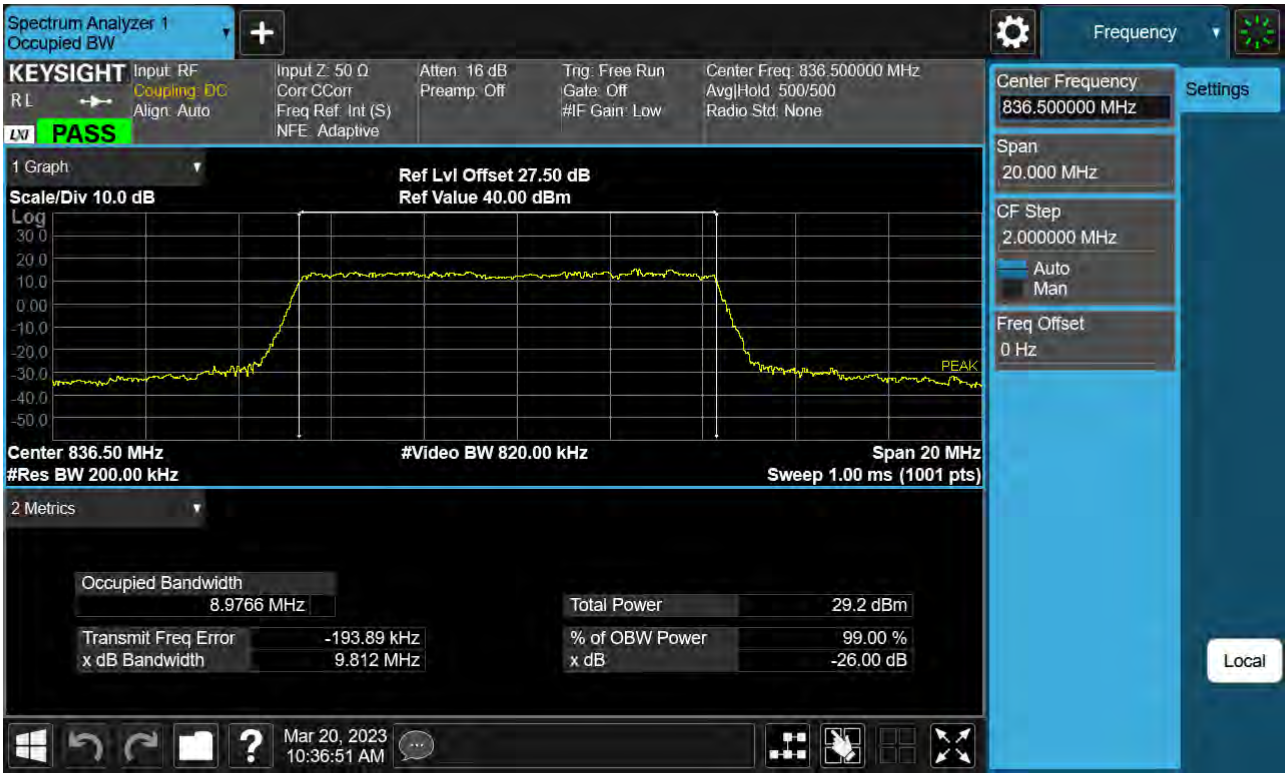


Sub6 n26. Occupied Bandwidth Plot (10 M BW Ch.167300 BPSK_RB 50_0)

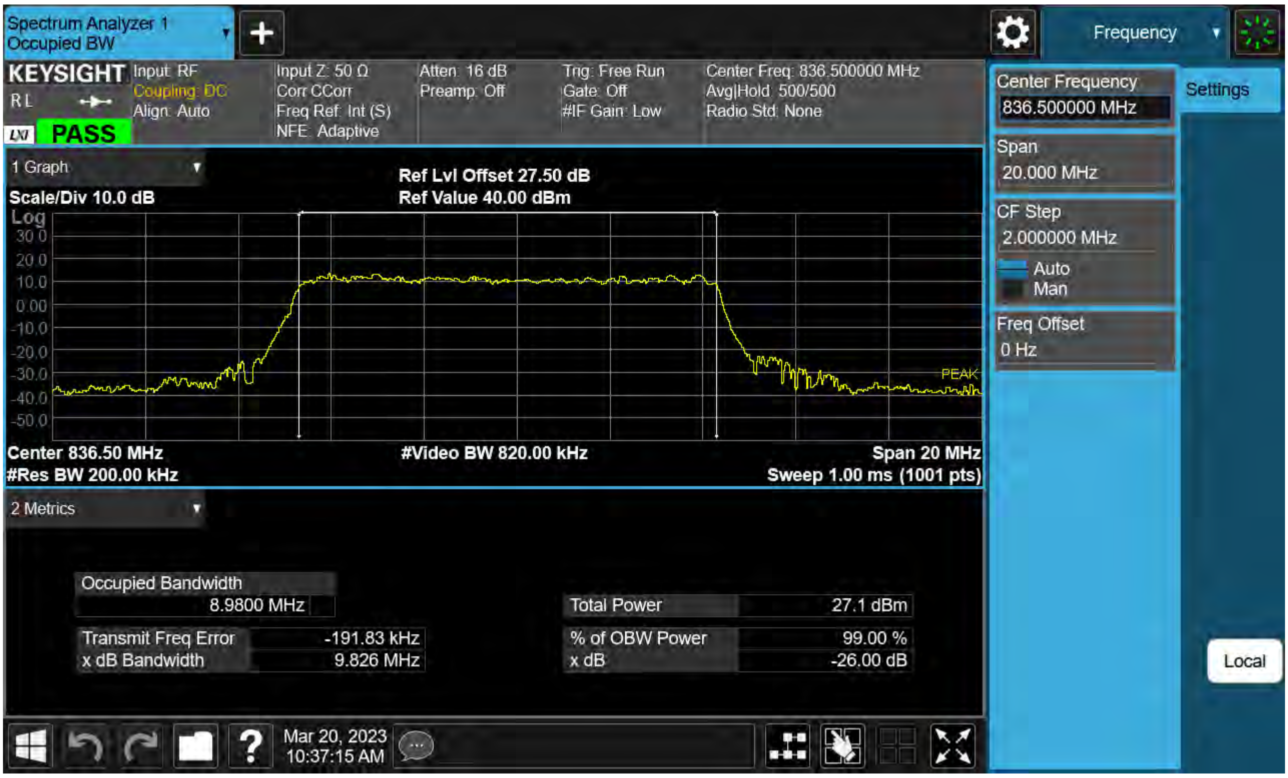
Sub6 n26. Occupied Bandwidth Plot (10 M BW Ch.167300 QPSK_RB 50_0)

Sub6 n26. Occupied Bandwidth Plot (10 M BW Ch.167300 16QAM_RB 50_0)

Sub6 n26. Occupied Bandwidth Plot (10 M BW Ch.167300 64QAM_RB 50_0)



Sub6 n26. Occupied Bandwidth Plot (10 M BW Ch.167300 256QAM_RB 50_0)



Sub6 n26. Occupied Bandwidth Plot (15 M BW Ch.167300 BPSK RB 75_0)

Sub6 n26. Occupied Bandwidth Plot (15 M BW Ch.167300 QPSK RB 75_0)

Sub6 n26. Occupied Bandwidth Plot (15 M BW Ch.167300 16QAM RB 75_0)

Sub6 n26. Occupied Bandwidth Plot (15 M BW Ch.167300 64QAM RB 75_0)

Sub6 n26. Occupied Bandwidth Plot (15 M BW Ch.167300 256QAM RB 75_0)

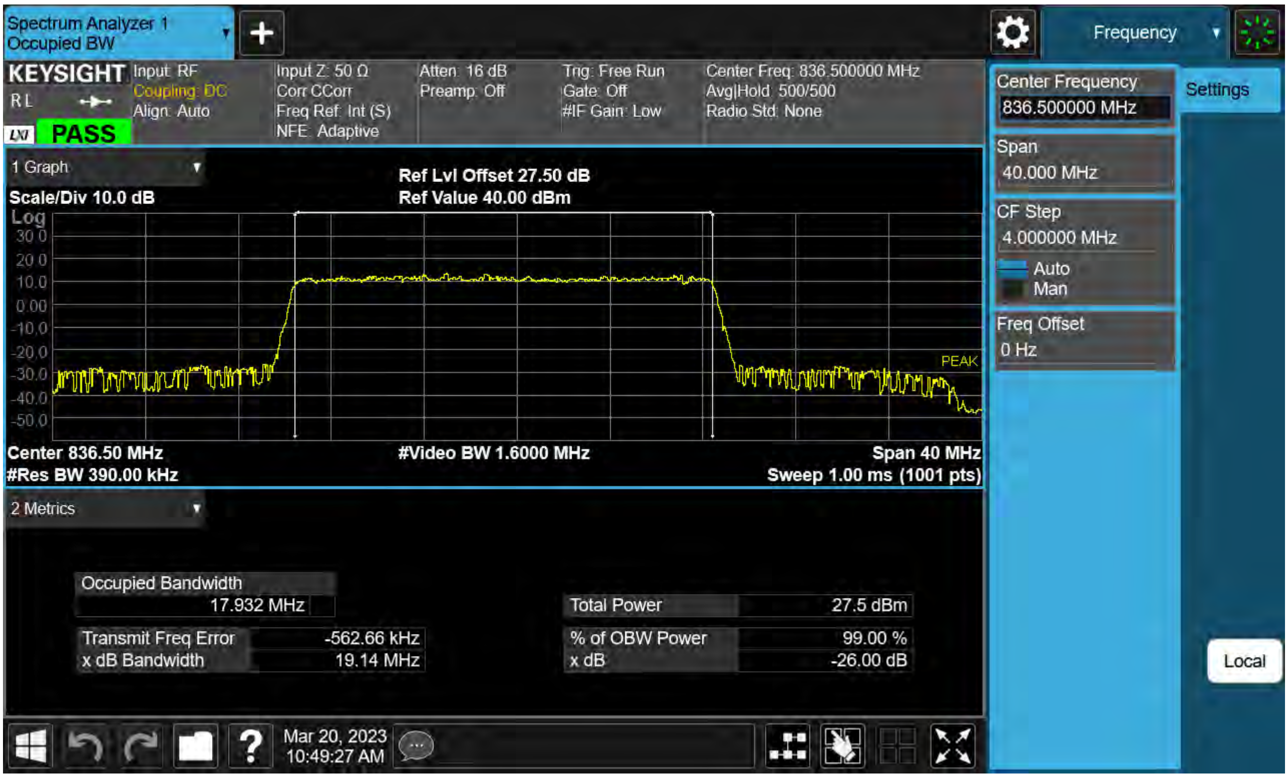
Sub6 n26. Occupied Bandwidth Plot (20 M BW Ch.167300 BPSK RB 100_0)

Sub6 n26. Occupied Bandwidth Plot (20 M BW Ch.167300 QPSK RB 100_0)

Sub6 n26. Occupied Bandwidth Plot (20 M BW Ch.167300 16QAM RB 100_0)

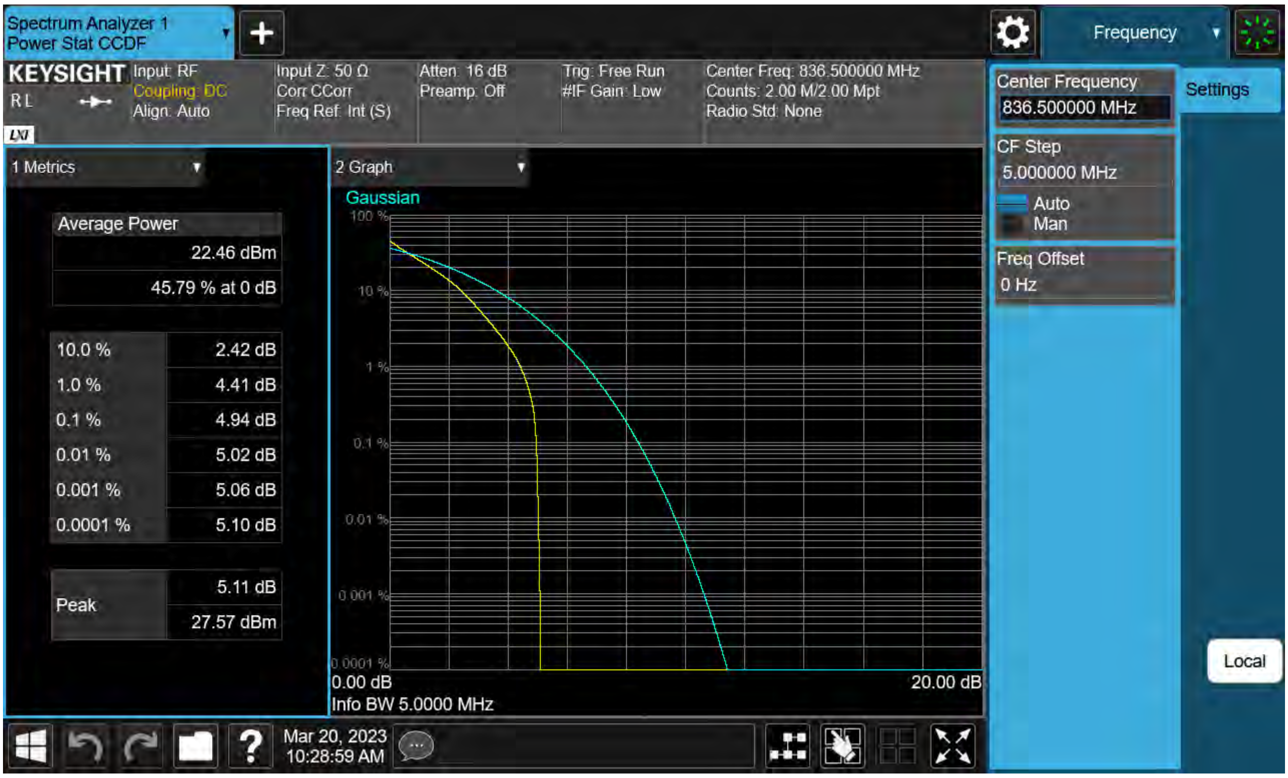
Sub6 n26. Occupied Bandwidth Plot (20 M BW Ch.167300 64QAM RB 100_0)

Sub6 n26. Occupied Bandwidth Plot (20 M BW Ch.167300 256QAM RB 100_0)



Sub6 n26. PAR Plot (5 M BW Ch.167300 BPSK_RB 25_0)

Sub6 n26. PAR Plot (5 M BW Ch.167300 QPSK_RB 25_0)



Sub6 n26. PAR Plot (5 M BW Ch.167300 16QAM_RB 25_0)

Sub6 n26. PAR Plot (5 M BW Ch.167300 64QAM_RB 25_0)

Sub6 n26. PAR Plot (5 M BW Ch.167300 256QAM_RB 25_0)

Sub6 n26. PAR Plot (10 M BW Ch.167300 BPSK_RB 50_0)

Sub6 n26. PAR Plot (10 M BW Ch.167300 QPSK_RB 50_0)

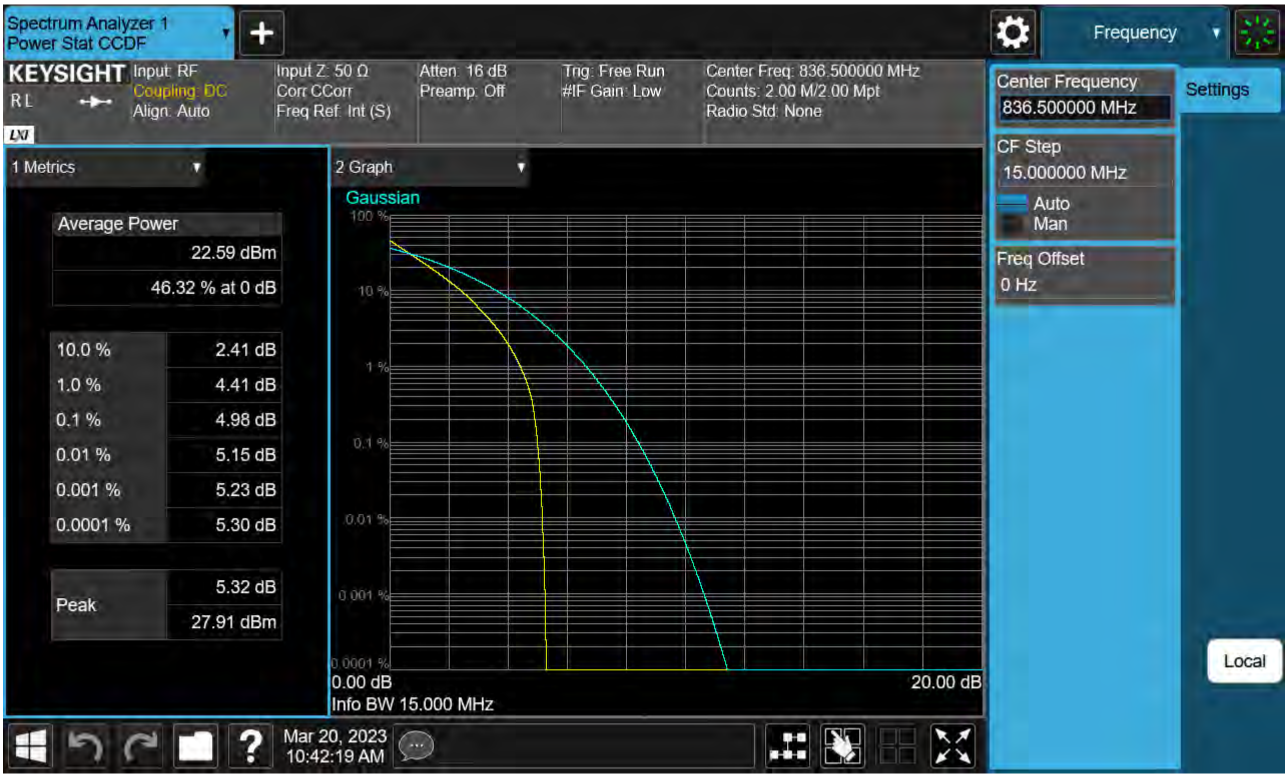
Sub6 n26. PAR Plot (10 M BW Ch.167300 16QAM_RB 50_0)

Sub6 n26. PAR Plot (10 M BW Ch.167300 64QAM_RB 50_0)

Sub6 n26. PAR Plot (10 M BW Ch.167300 256QAM_RB 50_0)

Sub6 n26. PAR Plot (15 M BW Ch.167300 BPSK RB 75_0)

Sub6 n26. PAR Plot (15 M BW Ch.167300 QPSK RB 75_0)



Sub6 n26. PAR Plot (15 M BW Ch.167300 16QAM RB 75_0)

Sub6 n26. PAR Plot (15 M BW Ch.167300 64QAM RB 75_0)

Sub6 n26. PAR Plot (15 M BW Ch.167300 256QAM RB 75_0)

Sub6 n26. PAR Plot (20 M BW Ch.167300 BPSK RB 100_0)

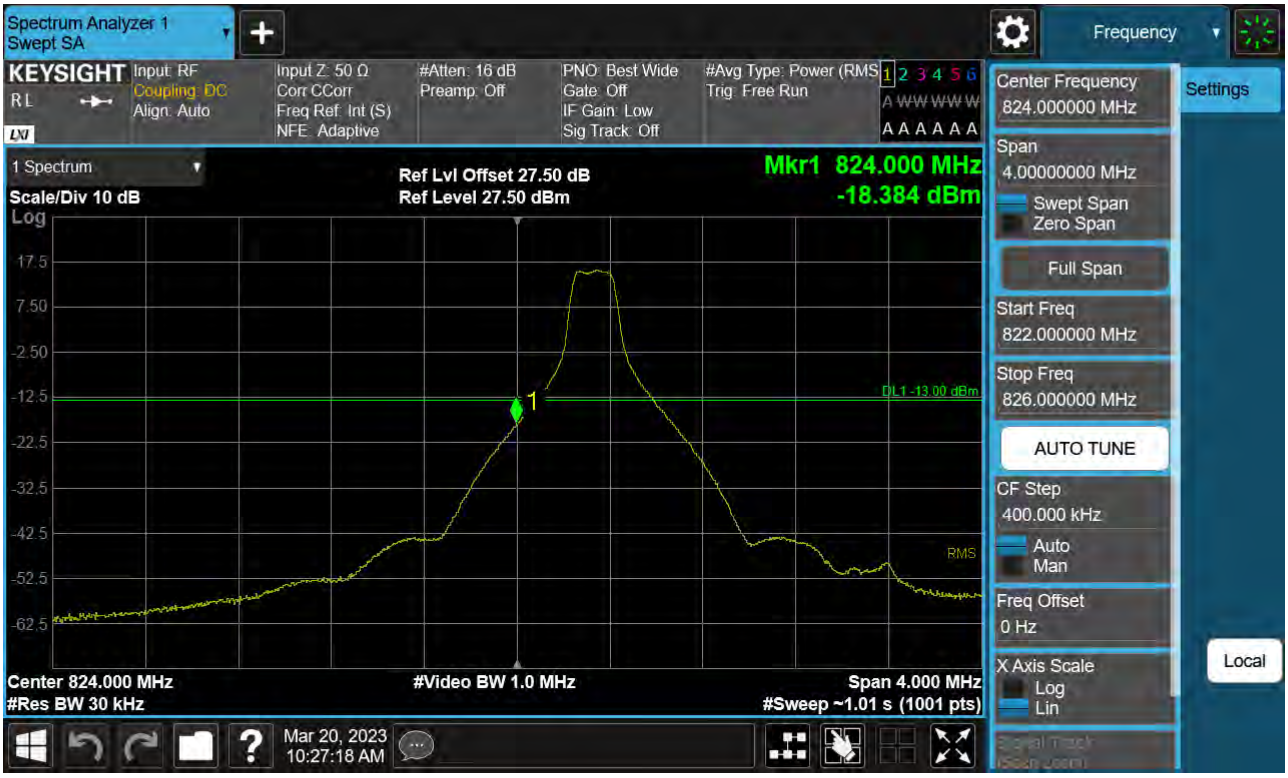
Sub6 n26. PAR Plot (20 M BW Ch.167300 QPSK RB 100_0)

Sub6 n26. PAR Plot (20 M BW Ch.167300 16QAM RB 100_0)

Sub6 n26. PAR Plot (20 M BW Ch.167300 64QAM RB 100_0)

Sub6 n26. PAR Plot (20 M BW Ch.167300 256QAM RB 100_0)

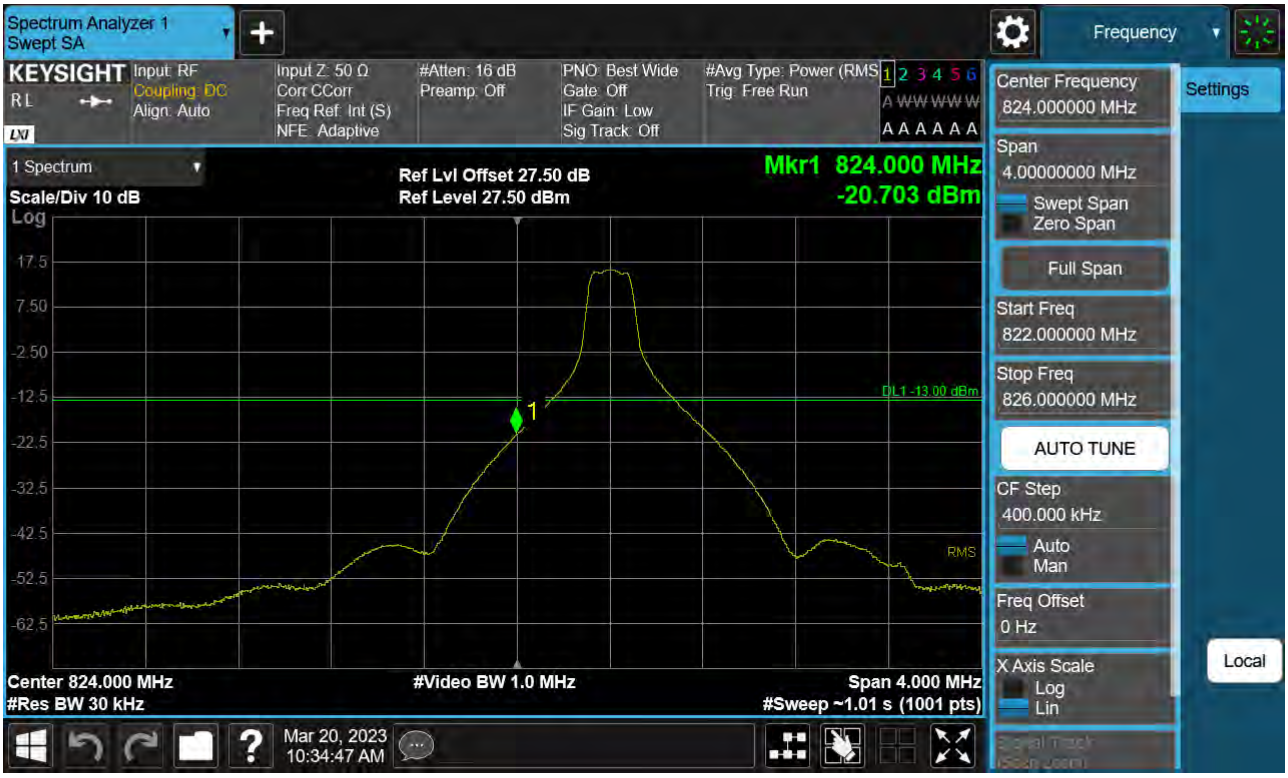
Sub6 n26. Lower Band Edge Plot (5 M BW Ch.165300 BPSK_RB 1_Offset 0)



Sub6 n26. Lower Band Edge Plot (5 M BW Ch.165300 BPSK_RB 25_Offset 0)

Sub6 n26. Lower Extended Band Edge Plot (5 M BW Ch.165300 BPSK_RB 25_0)

Sub6 n26. Lower Band Edge Plot (10 M BW Ch.165800 BPSK_RB 1_Offset 0)



Sub6 n26. Lower Band Edge Plot (10 M BW Ch.165800 BPSK_RB 50_Offset 0)

Sub6 n26. Lower Extended Band Edge Plot (10 M BW Ch.165800 BPSK_RB 50_0)

Sub6 n26. Lower Band Edge Plot (15 M BW Ch.166300 BPSK_RB 1_Offset 0)

Sub6 n26. Lower Band Edge Plot (15 M BW Ch.166300 BPSK_RB 75_Offset 0)

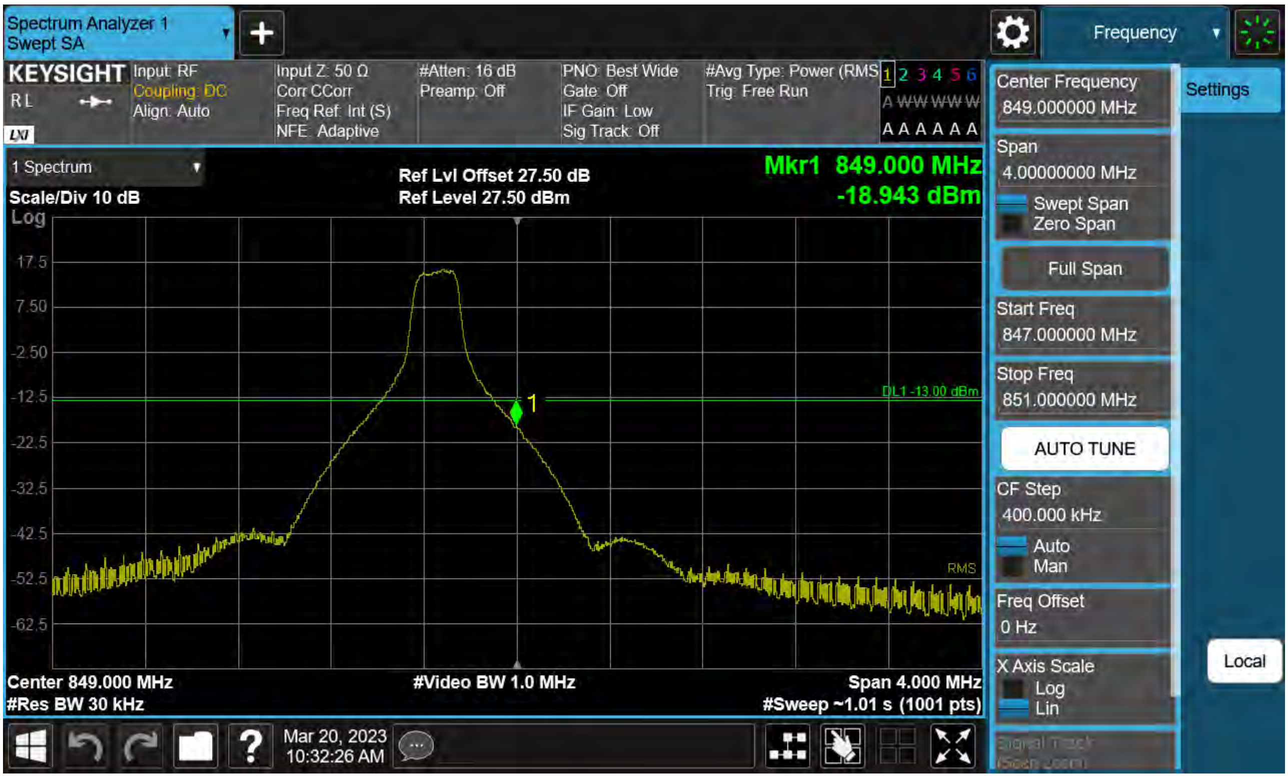
Sub6 n26. Lower Extended Band Edge Plot (15 M BW Ch.166300 BPSK_RB 75_0)

Sub6 n26. Lower Band Edge Plot (20 M BW Ch.166800 BPSK_RB 1_Offset 0)

Sub6 n26. Lower Band Edge Plot (20 M BW Ch.166800 BPSK_RB 100_Offset 0)

Sub6 n26. Lower Extended Band Edge Plot (20 M BW Ch.166800 BPSK_RB 100_0)

Sub6 n26. Upper Band Edge Plot (5 M BW Ch.169300 BPSK_RB 1_Offset 24)



Sub6 n26. Upper Band Edge Plot (5 M BW Ch.169300 BPSK_RB 25_Offset 0)

Sub6 n26. Upper Extended Band Edge Plot (5 M BW Ch.169300 BPSK_RB 25_0)

Sub6 n26. Upper Band Edge Plot (10 M BW Ch.168800 BPSK_RB 1_Offset 49)

Sub6 n26. Upper Band Edge Plot (10 M BW Ch.168800 BPSK_RB 50_Offset 0)

Sub6 n26. Upper Extended Band Edge Plot (10 M BW Ch.168800 BPSK_RB 50_0)

Sub6 n26. Upper Band Edge Plot (15 M BW Ch.168300 BPSK_RB 1_Offset 74)

Sub6 n26. Upper Band Edge Plot (15 M BW Ch.168300 BPSK_RB 75_Offset 0)

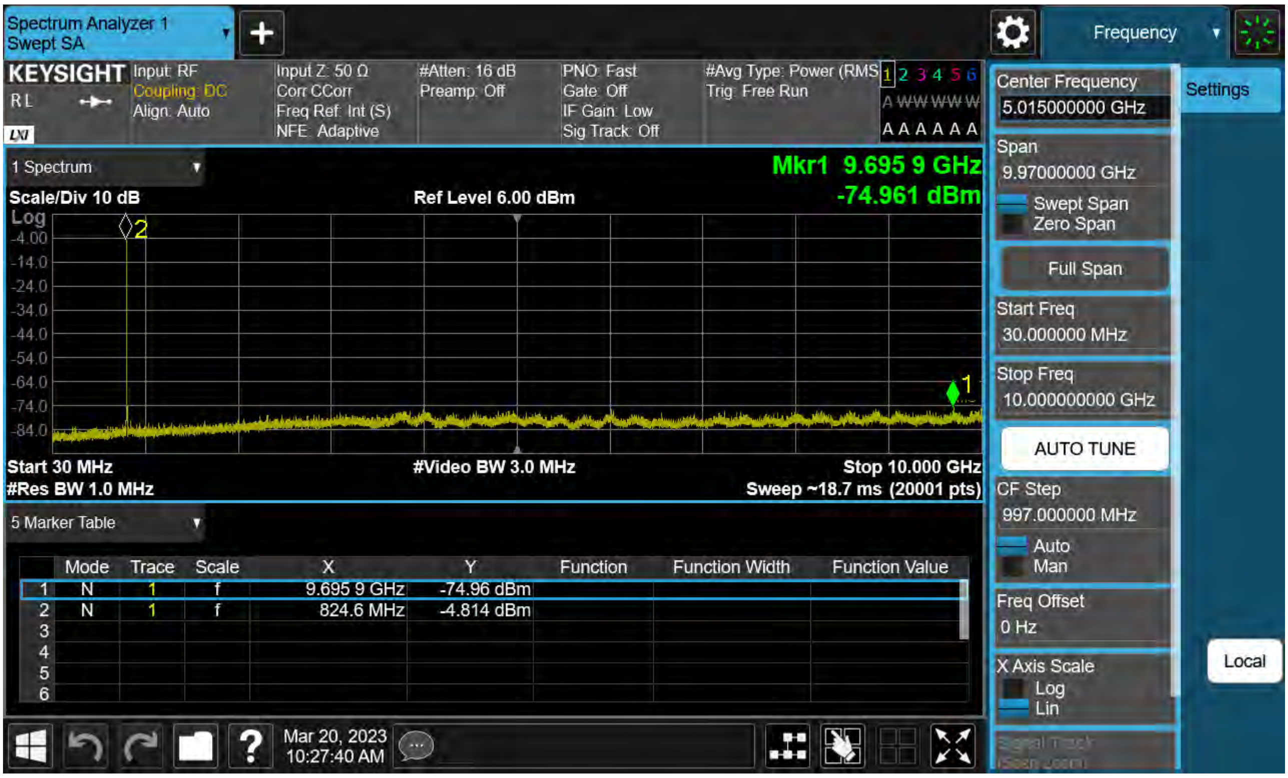
Sub6 n26. Upper Extended Band Edge Plot (15 M BW Ch.168300 BPSK_RB 75_0)

Sub6 n26. Upper Band Edge Plot (20 M BW Ch.167800 BPSK_RB 1_Offset 99)

Sub6 n26. Upper Band Edge Plot (20 M BW Ch.167800 BPSK_RB 100_Offset 0)

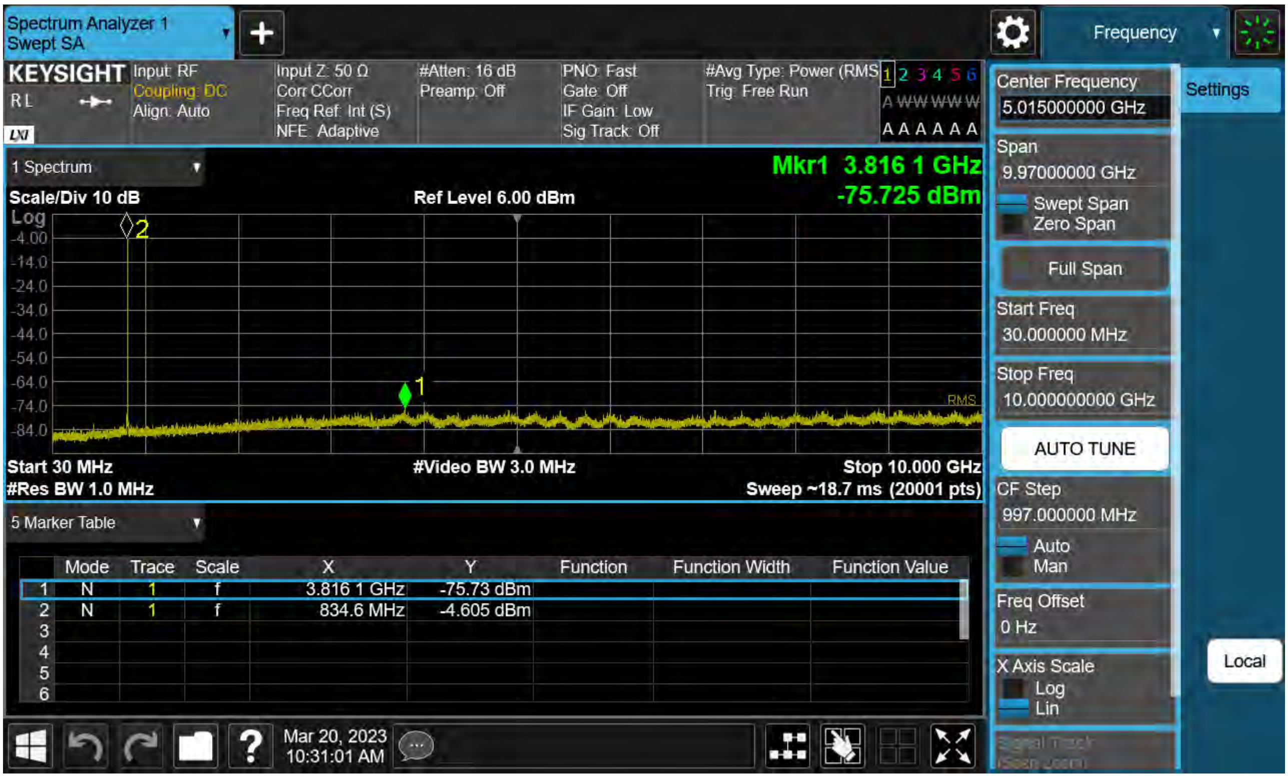
Sub6 n26. Upper Extended Band Edge Plot (20 M BW Ch.167800 BPSK_RB 100_0)

Sub6 n26. Conducted Spurious Plot (165300ch_5 MHz_BPSK_RB 1_0)

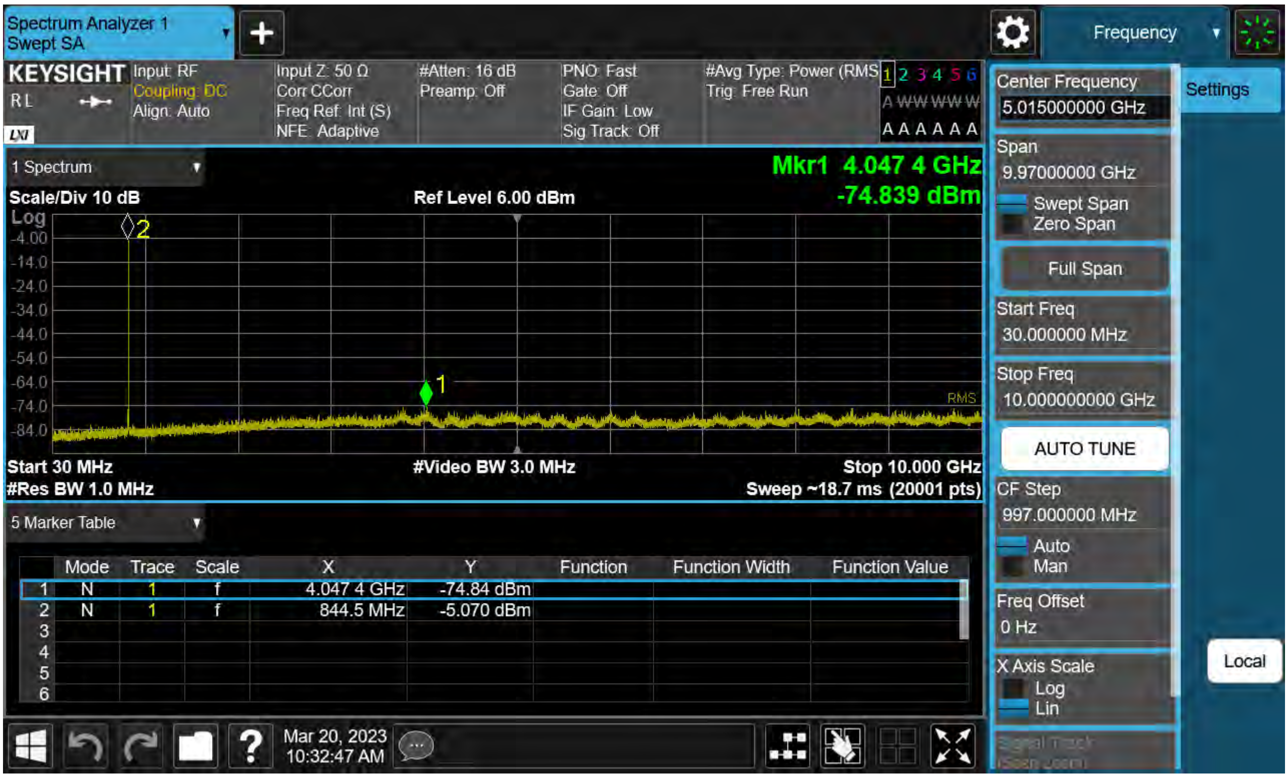


	Mode	Trace	Scale	X	Y	Function	Function Width	Function Value
1	N	1	f	9.695 9 GHz	-74.96 dBm			
2	N	1	f	824.6 MHz	-4.814 dBm			
3								
4								
5								
6								

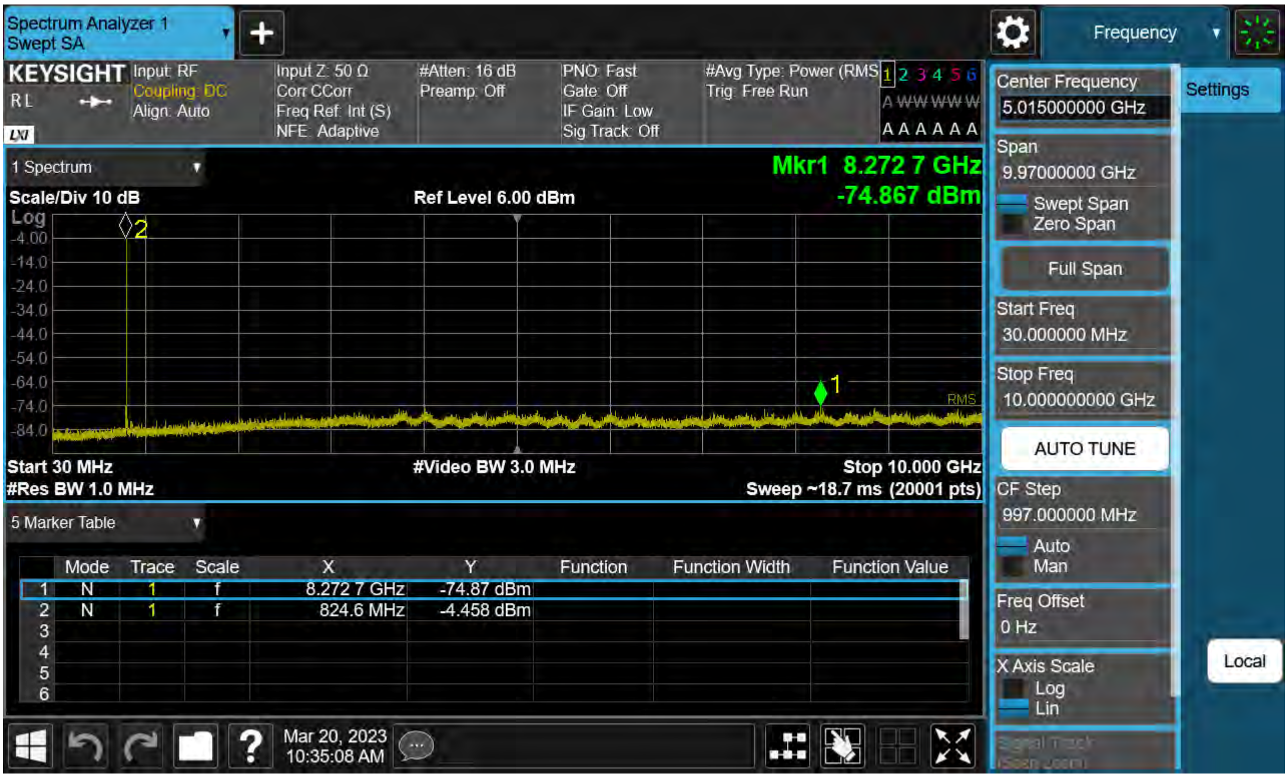
Sub6 n26. Conducted Spurious Plot (167300ch_5 MHz_BPSK_RB 1_0)



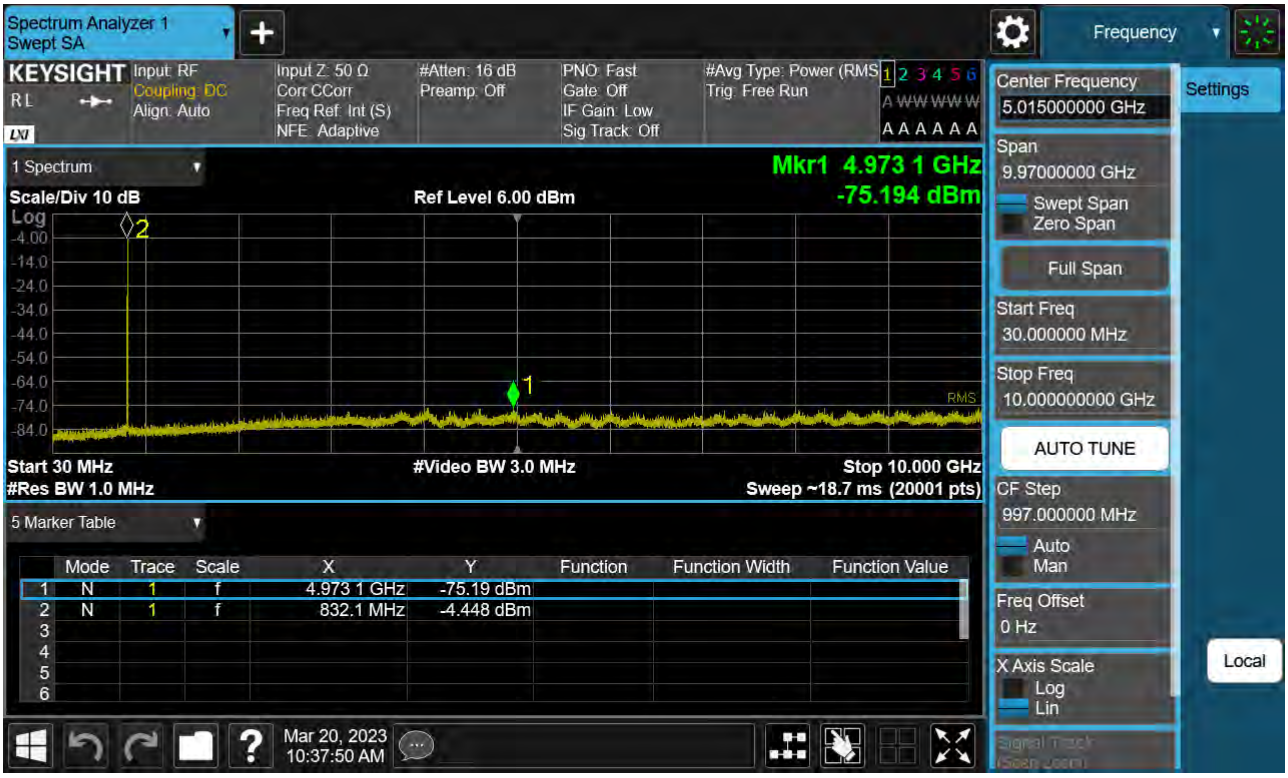
Sub6 n26. Conducted Spurious Plot (169300ch_5 MHz_BPSK_RB 1_0)



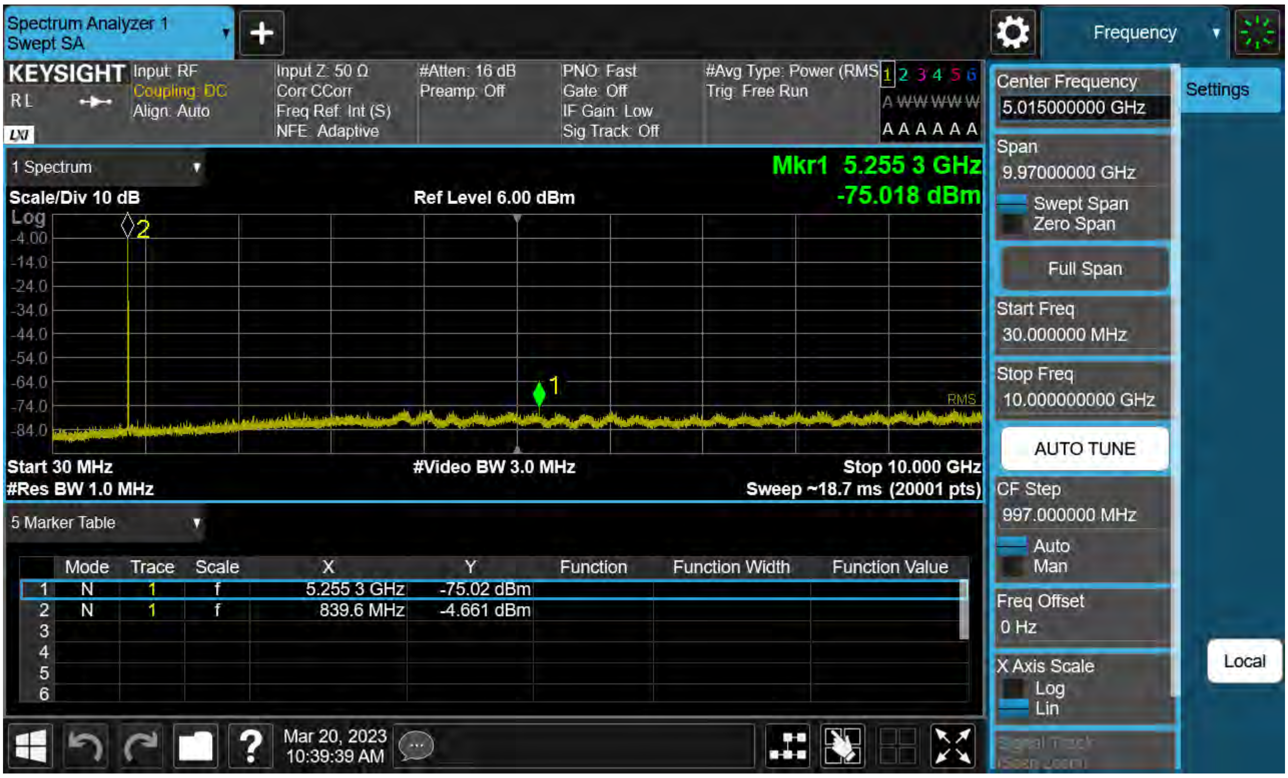
Sub6 n26. Conducted Spurious Plot (165800ch_10 MHz_BPSK_RB 1_0)



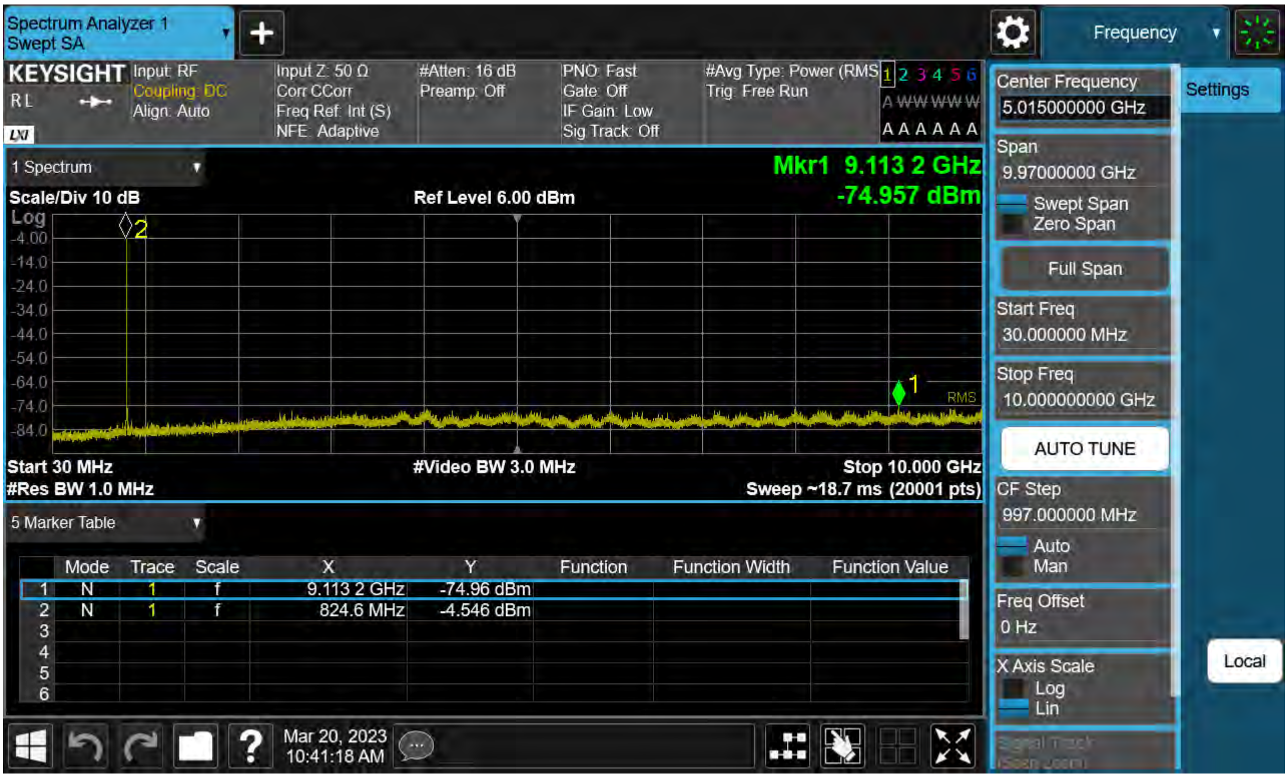
Sub6 n26. Conducted Spurious Plot (167300ch_10 MHz_BPSK_RB 1_0)



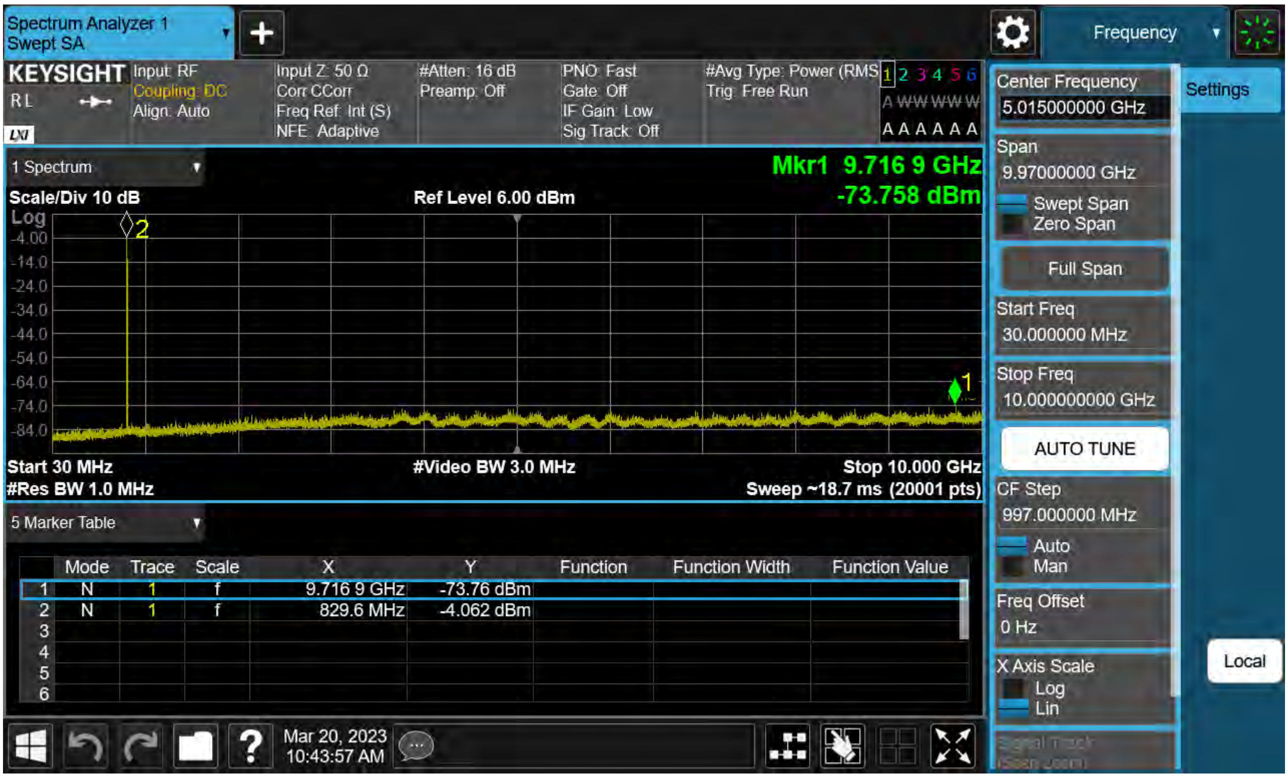
Sub6 n26. Conducted Spurious Plot (168800ch_10 MHz_BPSK_RB 1_0)



Sub6 n26. Conducted Spurious (166300ch_15 MHz_BPSK_RB 1_0)

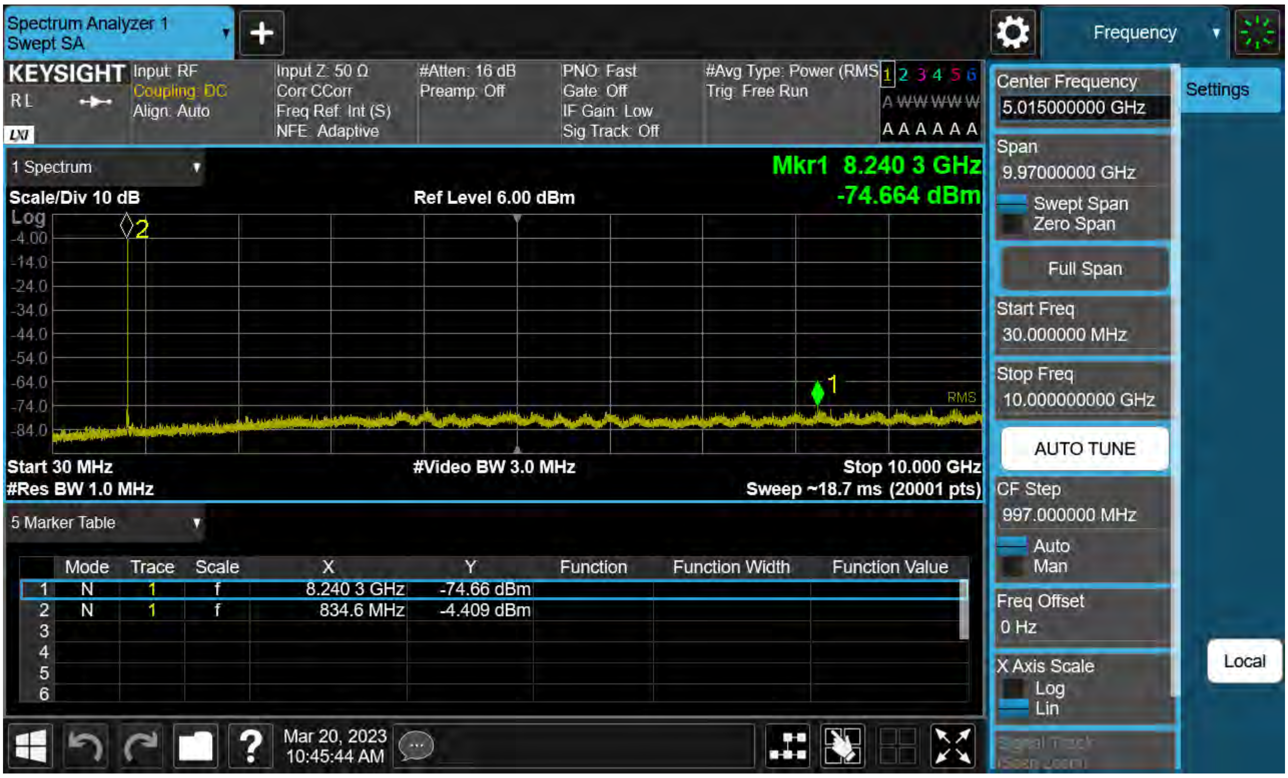


Sub6 n26. Conducted Spurious (167300ch_15 MHz_BPSK_RB 1_0)

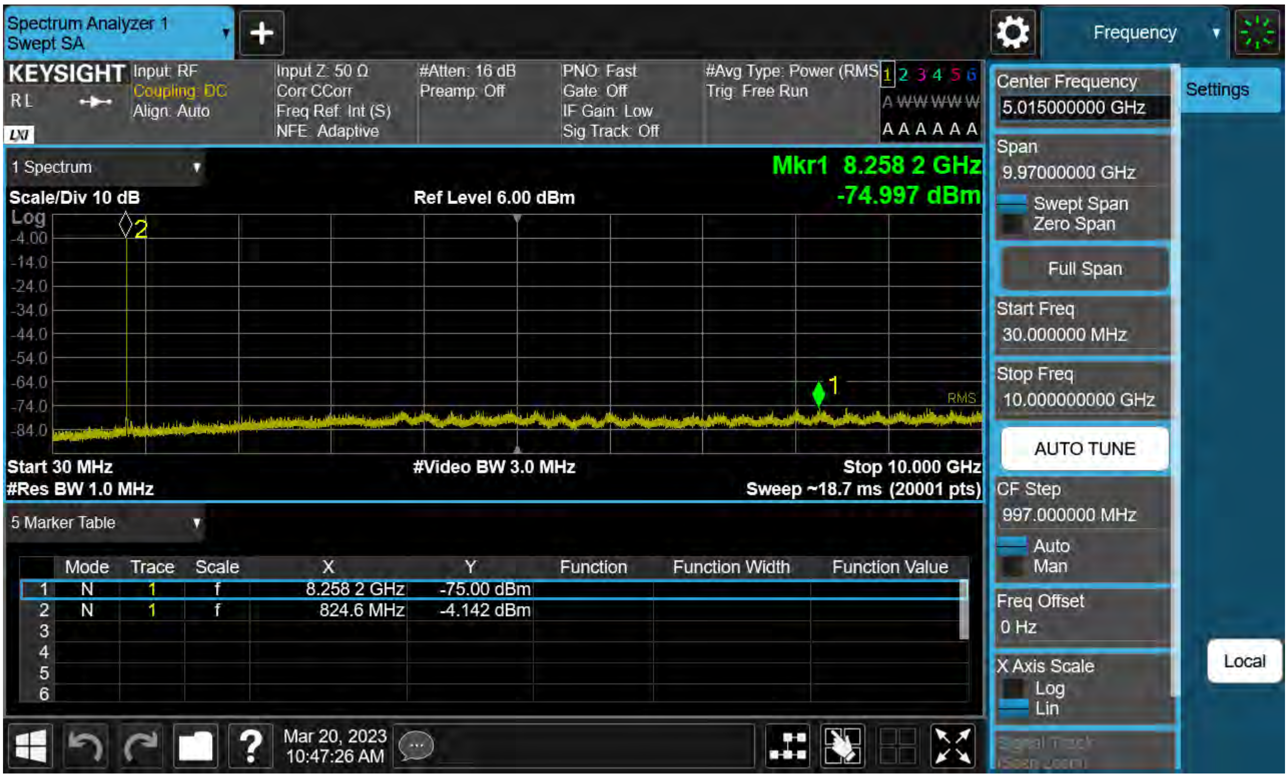


	Mode	Trace	Scale	X	Y	Function	Function Width	Function Value
1	N	1	f	9.716 9 GHz	-73.76 dBm			
2	N	1	f	829.6 MHz	-4.062 dBm			
3								
4								
5								
6								

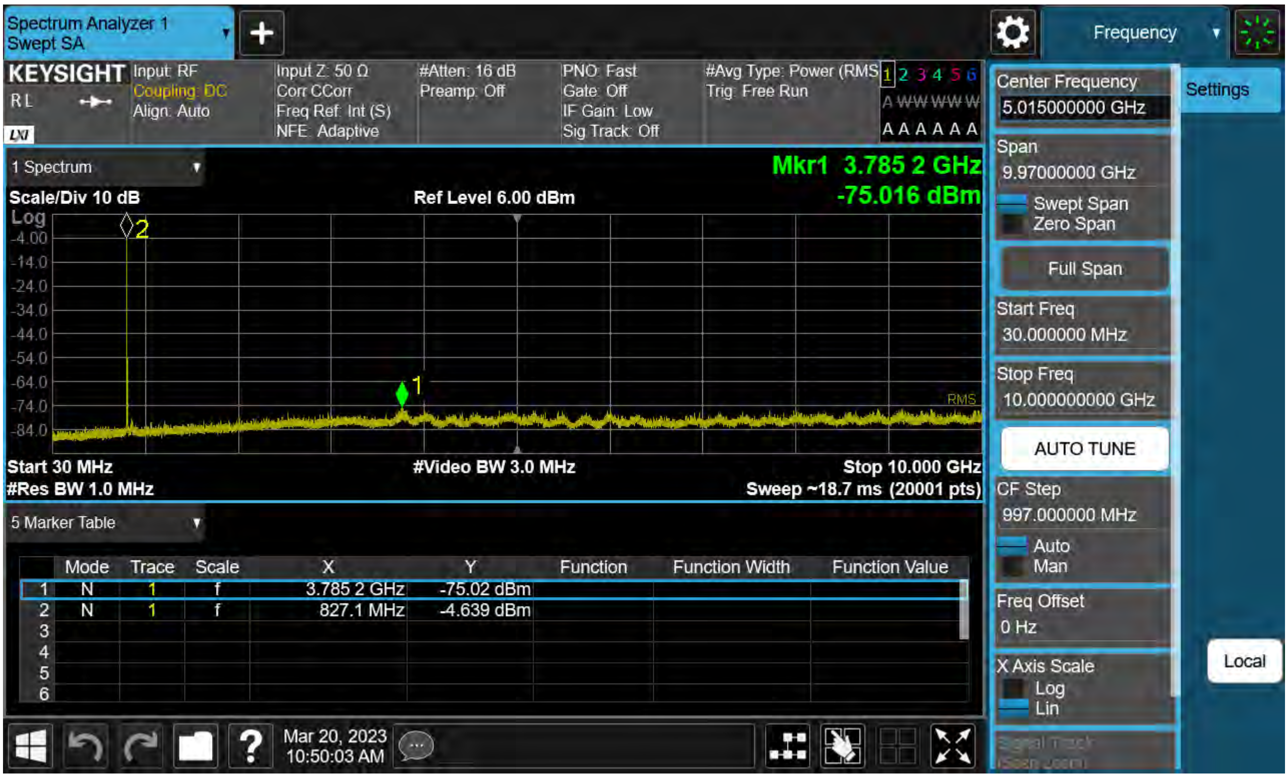
Sub6 n26. Conducted Spurious (168300ch_15 MHz_BPSK_RB 1_0)



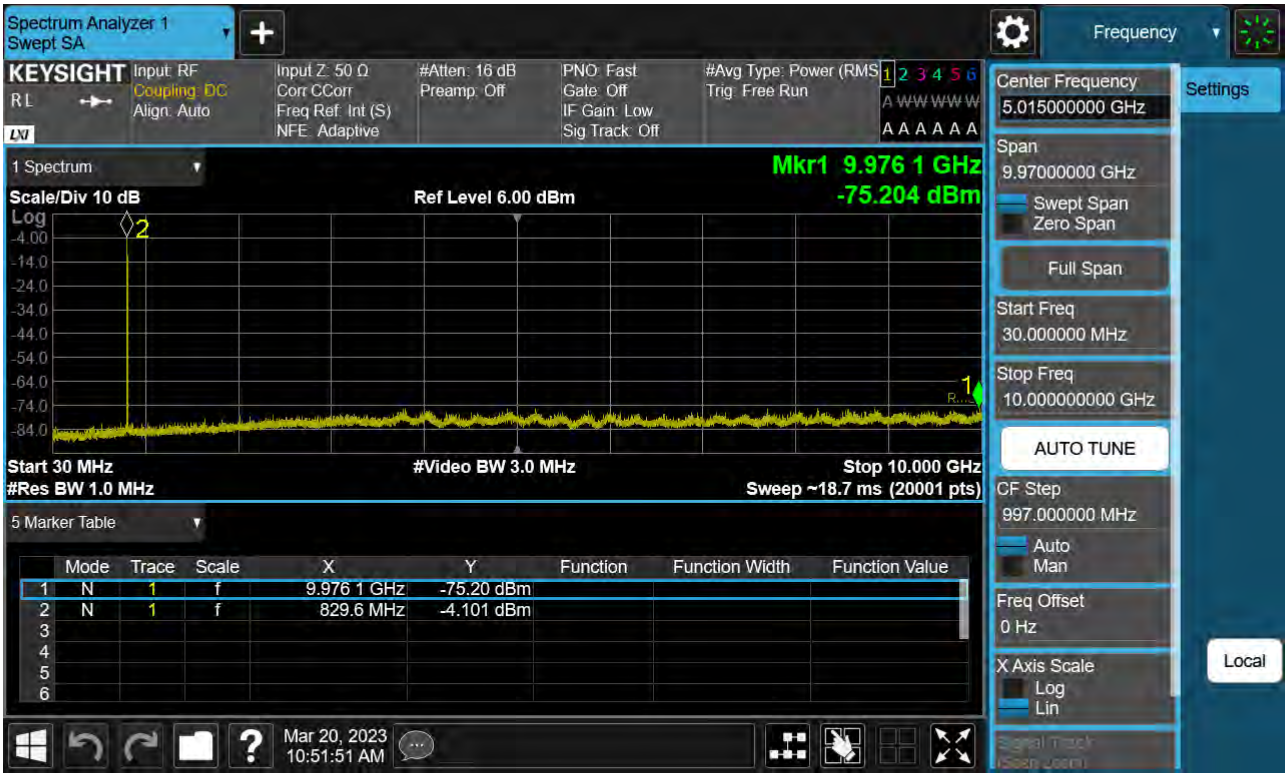
Sub6 n26. Conducted Spurious (166800ch_20 MHz_BPSK_RB 1_0)



Sub6 n26. Conducted Spurious (167300ch_20 MHz_BPSK _RB 1_0)



Sub6 n26. Conducted Spurious (167800ch_20 MHz_BPSK_RB 1_0)



	Mode	Trace	Scale	X	Y	Function	Function Width	Function Value
1	N	1	f	9.976 1 GHz	-75.20 dBm			
2	N	1	f	829.6 MHz	-4.101 dBm			
3								
4								
5								
6								

10. ANNEX A_ TEST SETUP PHOTO

Please refer to test setup photo file no. as follows;

No.	Description
1	HCT-RF-2305-FC023-P